Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

General Description

The MAX35103 is a time-to-digital converter with built-in amplifier and comparator targeted as a low-cost analog front-end solution for the ultrasonic heat meter and flow meter markets. It is similar to the MAX35101, but consumes about half the average power and increases the maximum ToF measurement frequency in event timing mode from 2Hz to 16Hz.

With a time measurement accuracy of 20ps and automatic differential time-of-flight (ToF) measurement, this device makes for simplified computation of liquid flow.

Average power consumption is the lowest available with ultra-low 5.5μ A ToF measurement and < 125nA duty-cycled temperature measurement.

Applications

- Ultrasonic Heat Meters
- Ultrasonic Water Meters
- Ultrasonic Gas Meters

Benefits and Features

- High Accuracy Flow Measurement for Billing and Leak Detection
 - Time-to-Digital Accuracy Down to 20ps
 - Measurement Range Up to 8ms
 - Two Channels: Single-Stop Channel
- High Accuracy Temperature Measurement for Precise Heat and Flow Calculations
 - · Up to Four 2-Wire Sensors
 - PT1000 and PT500 RTD Support
- Maximizes Battery Life with Low Device and Overall
 System Power
 - Ultra-Low 5µA ToF Measurement and < 125nA Duty-Cycled Temperature Measurement
 - Event Timing Mode Reduces Host Microcontroller Overhead to Minimize System Power Consumption
 - 2.3V to 3.6V Single-Supply Operation
- High-Integration Solution Minimizes Parts Count and Reduces BOM Cost
 - 8KB of Nonvolatile Flash Memory for Data Logging
 - Built-in Real Time Clock
 - Small, 5mm x 5mm, 32-Pin TQFP Package
 - -40°C to +85°C Operation

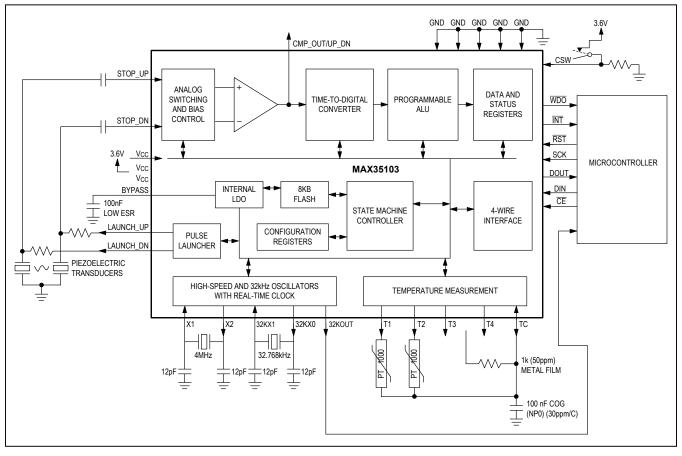
Ordering Information appears at end of data sheet.



19-7361; Rev 1; 1/15

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Typical Application Circuit



Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Absolute Maximum Ratings

(Voltages relative to ground.)
Voltage Range on V _{CC} Pins0.5V to +4.0V
Voltage Range on All Other Pins
(not to exceed 4.0V)0.5V to (V _{CC} + 0.5V)
Continuous Power Dissipation ($T_A = +70^{\circ}C$)
TQFP (derate 27.80mW/°C above +70°C)2222.20mW

Operating Temperature Range	40°C to +85°C
Junction Temperature	+150°C
Storage Temperature Range	55°C to +125°C
Lead Temperature (soldering, 10s)	+300°C
Soldering Temperature (reflow)	+260°C
ESD Protection (All Pins, Human Body Model)±2kV

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Package Thermal Characteristics (Note 1)

TQFP

Junction-to-Case Thermal Resistance (θ_{JC})......4°C/W

Note 1: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to <u>www.maximintegrated.com/thermal-tutorial</u>.

Recommended Operating Conditions

 $(T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted.})$ (Notes 2, 3)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP MAX	UNITS
Supply Voltage	V _{CC}		2.3	3.0 3.6	V
Input Logic 1 (RST, CSW, SCK, DIN, CE)	V _{IH}		Vcc x 0.7	Vcc + 0.3	V
Input Logic 0 (RST, CSW, SCK, DIN, CE)	V _{IL}		-0.3	Vcc x 0.3	V
Input Logic 1 (32KX1)	V _{IH32KX1}		V _{CC} x 0.85	5 V _{CC} + 0.3	V
Input Logic 0 (32KX1)	VIL32KX1		-0.3	V _{CC} x 0.15	V

Electrical Characteristics

 $(V_{CC} = 2.3V \text{ to } 3.6V, T_A = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}, \text{ unless otherwise noted. Typical values are at } V_{CC} = 3.0V \text{ and } T_A = +25^{\circ}\text{C}.)$ (Notes 2, 3)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP MAX	UNITS
Input Leakage (CSW, RST, SCK, DIN, CE)	١L		-0.1	+0.1	μA
Output Leakage (INT, WDO, T1,T2,T3,T4)	OL		-0.1	+0.1	μA
Output Voltage Low (32KOUT)	Vol32K	2mA		0.2 x V _{CC}	V
Output Voltage High (32KOUT)	Vонз2к	-1mA	0.8 x Vcc	;	V
Output Voltage High (DOUT, CMP_OUT/UP_DN)	VOH	-4mA	0.8 x V _{CC}		V
Output Voltage High (TC)	Vонтс	V _{CC} = 3.3V, I _{OUT} = -4mA	2.9	3.1	V

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Electrical Characteristics (continued)

(V_{CC} = 2.3V to 3.6V, T_A = -40°C to +85°C, unless otherwise noted. Typical values are at V_{CC} = 3.0V and T_A = +25°C.) (Notes 2, 3)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
Output Voltage High (Launch_UP, Launch_DN)	VOHLAUCH	VCC = 3.3V, IOUT = -50mA	2.8	3.0		V
Output Voltage Low (WDO, INT, DOUT, CMP_OUT/UP_DN)	VOL	4mA		0	.2 x V _{CC}	V
Pulldown Resistance (TC)	RTC		650	1000	1500	Ω
Input Voltage Low (TC)	VILTC			0.36 x V _C	с	V
Output Voltage Low (Launch_UP, Launch_DN)	VOLLAUCH	V _{CC} = 3.3V, I _{OUT} = 50mA		0.2	0.4	V
Resistance (T1, T2, T3, T4)	Ron			1		Ω
Input Capacitance (CE, SCK, DIN, RST, CSW)	CIN	Not tested		7		pF
RST Low Time	trst				100	ns
CURRENT		<u>`</u>				
Standby Current	IDDQ	No oscillators running, T_A = +25°C		0.1	1	μA
32kHz OSC Current	I32KHZ	32kHz oscillator only (Note 4)		0.5	0.9	μA
4MHz OSC Current	I4MHZ	4MHz oscillator only (Note 4)		40	85	μA
LDO Bias Current	ICCLDO	I _{CCCPU} = 0 (Note 4)		15	50	μA
Time Measurement Unit Current	Ісстми	(Note 4)		4.5	8	mA
Calculator Current	ICCCPU			0.75	1.7	mA
Device Current Drain	ICC3	TOF_DIFF = 2 per second (3 hits), temperature = 1 per 30s		5.5		
Device Current Drain	ICC6	TOF_DIFF = 2 per second (6 hits), temperature = 1 per 30s		7.0		μA
FLASH Erase Current	IFLASH			0.5	1	mA
ANALOG RECEIVER						
Analog Input Voltage (STOP_UP, STOP_DN)	Vana		10	700	2 x V _{CC} x (3/8)	mV _{P-P}
Input Offset Step Size	VSTEP			1		mV
STOP_UP/STOP_DN Bias Voltage	VBIAS			Vcc x (3/8	3)	V
Receiver Sensitivity	Vana	Stop hit detect level (Note 5)	10			mV _{P-P}
TIME MEASUREMENT UNIT						
Measurement Range	tMEAS	Time of flight	8		8000	μs
Time Measurement Accuracy	tACC	Differential time measurement		20		ps
Time Measurement Resolution	tRES			3.8		ps

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Electrical Characteristics (continued)

(V_{CC} = 2.3V to 3.6V, T_A = -40°C to +85°C, unless otherwise noted. Typical values are at V_{CC} = 3.0V and T_A = +25°C.) (Notes 2, 3)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
FLASH		•				
Data Retention	DR	T _A = +25°C	100			Years
Flash Endurance	NFLASH	T _A = +25°C	20k			Cycles
Block Flash Erase Time	tERASE				50	ms
LDO Stabilization Time	^t STABLE			135		μs
Word Write Time	twrite			72	100	μs
Transfer Configuration to Flash Command Time	tCONFIG			35		ms
EXECUTION TIMES						
Power-On-Reset Time	t _{RESET}	Reset to POR INT		275		μs
INIT Command Time	t _{INIT}	Command received when INIT bit set		2.5		ms
Case Switch Time	tcsw	CSW pin logic-high until CSWI bit set		20		ns
CAL Command Time	t _{CAL}	Command received when CAL bit set		1.25		ms
SERIAL PERIPHERAL INTERFAC	E					
DIN to SCK Setup	tDC				20	ns
SCK to DIN Hold	tcDH			2	20	ns
SCK to DOUT Delay	tCDD			5	20	ns
SCK Low Time	to	V _{CC} ≥ 3.0V	25	4		
SCK LOW TIME	tCL	VCC = 2.3V	50	30		ns
SCK High Time	tсн		25	4		ns
		V _{CC} ≥ 3.0V			20	
SCK Frequency	tCLK	V _{CC} = 2.3V			10	MHz
CE to SCK Setup	tcc			5	40	ns
SCK to CE Hold	tссн				20	ns
CE Inactive Time	tсwн			2	40	ns
CE to DOUT High Impedance	tccz			5	20	ns

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Recommended External Crystal Characteristics

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
32kHz Nominal Frequency	f32K			32.768		kHz
32kHz Frequency Tolerance	Δf32K/f32K	T _A = +25°C	-20		+20	ppm
32kHz Load Capacitance	CL32K			12.5		pF
32kHz Series Resistance	Rs32K				70	kΩ
4MHz Crystal Nominal Frequency	F4M			4.000		MHz
4MHz Crystal Frequency Tolerance	∆f4M/f4M	T _A = +25°C	-30		+30	ppm
4MHz Crystal Load Capacitance	CL4M			12.0		pF
4MHz Crystal Series Resistance	R _{S4M}				120	Ω
4MHz Ceramic Nominal Frequency				4.000		MHz
4MHz Ceramic Frequency Tolerance		T _A = +25°C	-0.5		+0.5	%
4MHz Ceramic Load Capacitance				30		pF
4MHz Ceramic Series Resistance					30	Ω

Note 2: All voltages are referenced to ground. Current entering the device are specified as positive and currents exiting the device are negative.

Note 3: Limits are 100% production tested at $T_A = +25^{\circ}$ C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization.

Note 4: Currents are specified as individual block currents. Total current for a point in time can be calculated by taking the standby current and adding any block currents that are active at that time.

Note 5: Receiver sensitivity includes performance degradation contributed by STOP_UP and STOP_DN device pin input offset voltage and common mode drift.

Timing Diagrams

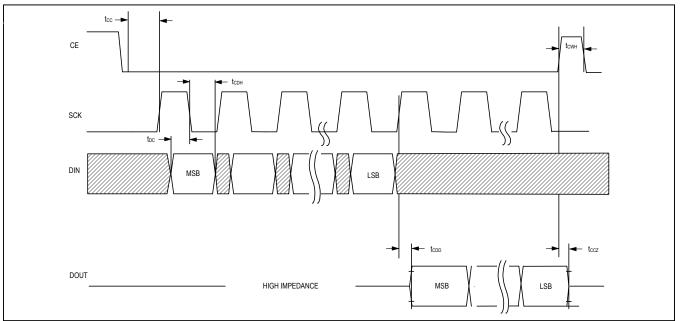


Figure 1. SPI Timing Diagram Read

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Timing Diagrams (continued)

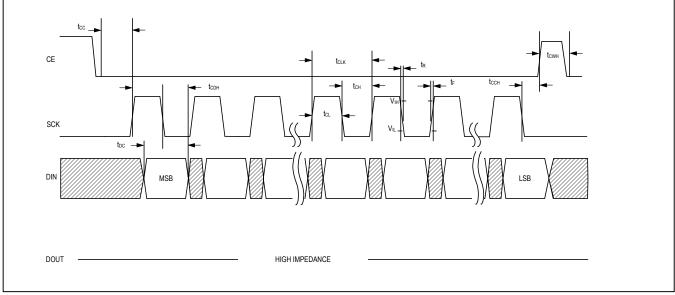
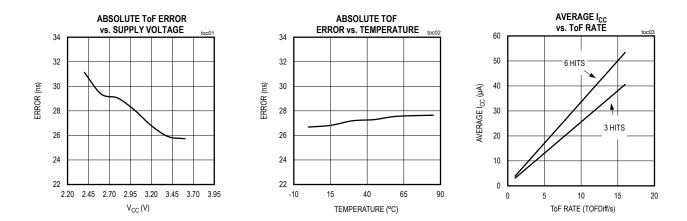


Figure 2. SPI Timing Diagram Write

Typical Operating Characteristics

(V_{CC} = 3.3V and T_A = +25°C, unless otherwise noted.)



Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Average I_{CC} vs. ToF Rate Configuration Settings

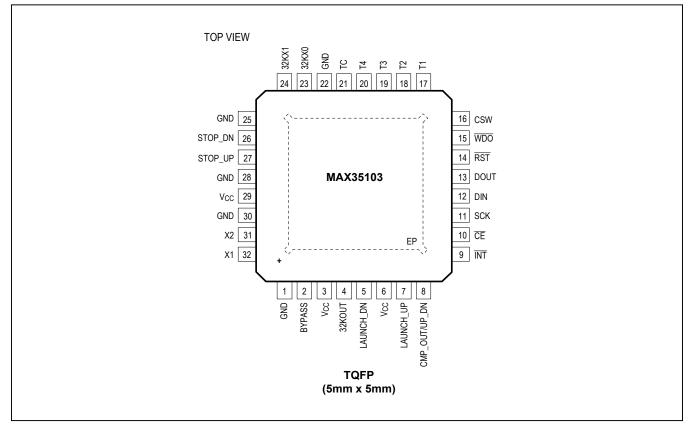
	6-HIT	SETTINGS	3-HIT SETTINGS		
CONTROL BIT(S)	VALUE	BIT SETTINGS	VALUE	BIT SETTINGS	
Calibration Usage	Disabled	CAL_USE = 0	Disabled	CAL_USE = 0	
Clock Setting Time	488µs	CLK_2[2:0] = 000	488µs	CLK_2[2:0] = 000	
Bias Charge Time	61µs	CT[1:0] = 00	61µs	CT[1:0] = 00	
Pulse Launch Frequency	1MHz	DPL[3:0] = 0001	1MHz	DPL[3:0] = 0001	
Pulse Launch Size	15	PL[7:0] = 00001111	15	PL[7:0] = 00001111	
ToF Duty Cycle	19.97ms	TOF_CYC[2:0] = 111	19.97ms	TOF_CYC[2:0] = 111	
Stop Hits	6	STOP[2:0] = 101	3	STOP[2:0] = 101	
T2 Wave Selector	Wave 2	T2WV[5:0] = 000110	Wave 2	T2WV[5:0] = 000110	
Hit1 Wave Select	7	HIT1WV[5:0] = 000111	7	HIT1WV[5:0] = 000111	
Hit2 Wave Select	8	HIT2WV[5:0] = 001000	8	HIT2WV[5:0] = 001000	
Hit3 Wave Select	9	HIT3WV[5:0] = 001001	9	HIT3WV[5:0] = 001001	
Hit4 Wave Select	10	HIT4WV[5:0] = 001010	n/a	n/a	
Hit5 Wave Select	11	HIT5WV[5:0] = 001011	n/a	n/a	
Hit6 Wave Select	12	HIT6WV[5:0] = 001100	n/a	n/a	
Temperature Port Number	4	TP[1:0] = 11	4	TP[1:0] = 11	
Preamble Temperature Cycle Number	1	PRECYC[2:0] = 001	1	PRECYC[2:0] = 001	
Port Cycle Time	256µs	PORTCYC[1:0] = 01	256µs	PORTCYC[1:0] = 01	

Notes:

This data is valid for the ceramic resonator. Crystal oscillator startup add ~0.5 μ A per TOFDiff. Since the ToF cycle time is long, the 4MHz oscillator power up twice.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Pin Configuration



Pin Description

PIN	NAME	FUNCTION
1, 22, 25, 28, 30	GND	Device Ground
2	BYPASS	Connect this pin to ground with a capacitor (100nF) to provide stability for the on-board low- dropout regulator that is used to supply the flash circuitry. The effective series resistance of this capacitor needs to be in the 1Ω to 2Ω range.
3, 6, 29	V _{CC}	Main Supply. Typically sourced from a single lithium cell.
4	32KOUT	CMOS Output. Repeats the 32kHz crystal oscillator frequency.
5	LAUNCH_DN	CMOS Pulse Output Transmission in Downstream Direction of Water Flow
7	LAUNCH_UP	CMOS Pulse Output Transmission in Upstream Direction of Water Flow
8	CMP_OUT/UP_DN	CMOS Output. Indicates the direction (upstream or downstream) of which the pulse launcher is currently launching pulses OR the comparator output.
9	ĪNT	Active-Low Open-Drain Interrupt Output. The pin is driven low when the device requires service from the host microprocessor.
10	CE	Active-Low CMOS Digital Input. Serial peripheral interface chip enable input.

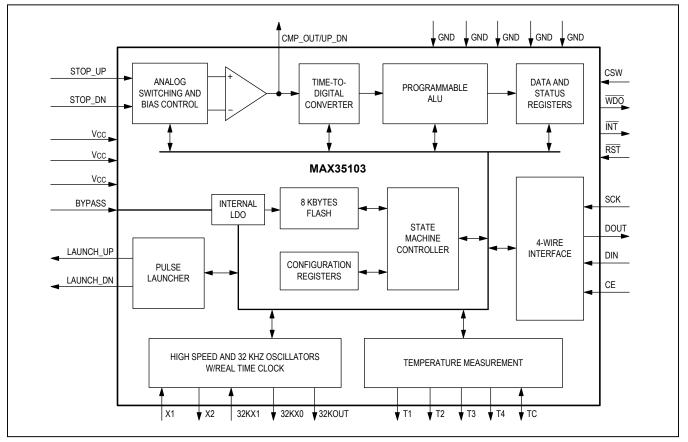
Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Pin Description (continued)

PIN	NAME	FUNCTION
11	SCK	CMOS Digital Input. Serial peripheral interface clock input.
12	DIN	CMOS Digital Input. Serial peripheral interface data input.
13	DOUT	CMOS Output. Serial peripheral interface data output.
14	RST	Active-Low CMOS Digital Reset Input
15	WDO	Active-Low Open-Drain Watchdog Output
16	CSW	CMOS Digital Input. Case Switch. Active-high tamper detect input.
17	T1	Open-Drain Probe 1 Temperature Measurement
18	T2	Open-Drain Probe 2 Temperature Measurement
19	Т3	Open-Drain Probe 3 Temperature Measurement
20	T4	Open-Drain Probe 4 Temperature Measurement
21	TC	Input/Output Temperature Measurement Capacitor Connection
23	32KX0	Connections for 32.768kHz Quartz Crystal. An external CMOS 32.768kHz oscillator can also drive the MAX35103. In this configuration, the 32KX1 pin is connected to the external oscillator
24	32KX1	signal and the 32KX0 pin is left unconnected.
26	STOP_DN	Downstream STOP Analog Input. Used for the signal that is received from the downstream transmission of a time-of-flight measurement.
27	STOP_UP	Upstream STOP Analog Input. Used for the signal that is received from the upstream transmission of a time-of-flight measurement.
31	X2	Connections for 4MULT Quarter Churchel A coronic reconctor con also be used
32	X1	Connections for 4MHz Quartz Crystal. A ceramic resonator can also be used.
_	EP	Exposed Pad. Connect to GND.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Block Diagram



Detailed Description

The MAX35103 is a time-to-digital converter with built-in amplifier and comparator targeted as a complete analog front-end solution for the ultrasonic heat meter and flow meter markets.

With automatic differential time-of-flight (TOF) measurement, this device makes for simplified computation of liquid flow. Early edge detection ensures measurements are made with consistent wave patterns to greatly improve accuracy and eliminate erroneous measurements. Built-in arithmetic logic unit provides TOF difference measurements. A programmable receiver hit accumulator can be utilized to minimize the host microprocessor access.

Multihit capability with stop-enable windowing allows the device to be fine-tuned for the application. Internal analog switches, an autozero amplifier/comparator, realtime clock (RTC), and programmable receiver sensitivity provide the analog interface and control for a minimal electrical bill of material solution. The RTC provides an event timing mode that is configurable and runs cyclic algorithms to minimize microprocessor interactivity and increase battery life.

For temperature measurement, the MAX35103 supports up to four (4) 2-wire PT1000/500 platinum resistive temperature detectors (RTD).

The MAX35103 offers an event timing mode that is configurable and runs cyclic algorithms to minimize microprocessor interactivity and increase battery life.

The real-time clock (RTC) provides one programmable alarm and watchdog functionality.

A simple opcode based 4-Wire SPI interface allows any microcontroller to effectively configure the device for its intended measurement.

On-board user flash allows the MAX35103 to be nonvolatile configurable and provides nonvolatile energy use data to be logged.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

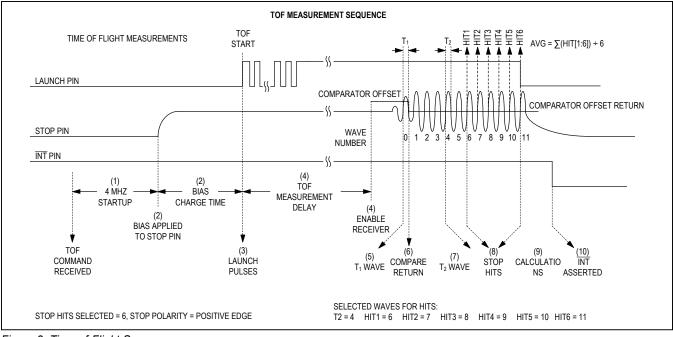


Figure 3. Time-of-Flight Sequence

Time-of-Flight (ToF) Measurement Operations

TOF is measured by launching pulses from one piezoelectric transducer and receiving the pulses at a second transducer. The time between when the pulses are launched and received is defined as the time of flight. The MAX35103 contains the functionality required to create a string of pulses, sense the receiving pulse string, and measure the time of flight. The MAX35103 can measure two separate TOFs, which are defined as TOF up and TOF down.

A TOF up measurement has pulses launched from the LAUNCH_UP pin, which is connected to the downstream transducer. The ultrasonic pulse is received at the upstream transducer, which is connected to the STOP_UP pin. A TOF down measurement has pulses launched from the LAUNCH_DN pin, which is connected to the upstream transducer. The ultrasonic pulse is received at the downstream transducer, which is connected to the STOP_DN pin.

TOF measurements can be initiated by sending either the TOF_UP, TOF_DN, or TOF_DIFF commands. TOF_DIFF measurements can also be automatically executed using event timing mode commands EVTMG1 or EVTMG2.

The steps involved in a single TOF measurement are described here and shown in Figure 3.

- 1) The 4MHz oscillator and LDO is enabled with a programmable settling delay time set by the CLK_S[2:0] bits in Calibration and Control register.
- A common-mode bias is enabled on the STOP pin. This bias charge time is set by the CT[1:0] bits in the TOF1 register.
- 3) Once the bias charge time has expired, the pulse launcher drives the appropriate LAUNCH pin with a programmable sequence of pulses. The number of pulses launched is set by the PL[7:0] bits in the TOF1 register. The frequency of these 50% dutycycle pulses is set by the DPL[3:0] bits, also in the TOF1 register. The start of these launch pulses generates a start signal for the time-to-digital converter (TDC) and is considered to be time zero for the TOF measurement. This is denoted by the start signal in the start/stop TDC timing (Figure 3).
- 4) After a programmable delay time set in TOF Measurement Delay register, the comparator and hit detector at the appropriate STOP pin are enabled. This delay allows the receiver to start recording hits when the received wave is expected, eliminating possible false hits from noise in the system.
- 5) Stop hits are detected according to the programmed preferred edge of the acoustic signal sequence received at the STOP pin according to the setting

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

of the STOP_POL bit in the TOF1 register. The first stop hit is detected when a wave received at the STOP pin exceeds the comparator offset voltage, which is set in the TOF6 and TOF7 registers. This first detected wave is wave number 0. The width of the wave's pulse that exceeds the comparator offset voltage is measured and stored as the t1 time.

- 6) The offset of the comparator then automatically and immediately switches to the comparator return offset, which is set in the TOF6 and TOF7 registers.
- 7) The t_2 wave is detected and the width of the t_2 pulse is measured and stored as the t_2 time. The wave number for the measurement of the t_2 wave width is set by the T2WV[5:0] bits in the TOF2 register.
- 8) The preferred number of stop hits are then detected. For each hit, the measured TOF is stored in the appropriate HITxUPINT and HITxUPFrac or HITxDNINT and HITxDNFRAC registers. The number of hits to detect is set by the STOP[2:0] bits in the TOF2 register. The wave number to measure for each stop hit is set by the HITx wave select bits in the TOF3, TOF4, and TOF5 registers.
- 9) After receiving all of the programmed hits, the MAX35103 calculates the average of the recorded hits and stores this to AVGUPINT and AVGUPFrac or AVGDNInt and AVGDNFrac. The ratio of t₁/t₂ and t₂/t_{ideal} are calculated and stored in the WVRUP or WVRDN register.
- 10) Once all of the hit data, wave ratios, and averages become available in the Results registers, the TOF

bit in the Interrupt Status register is set and the $\overline{\text{INT}}$ pin is asserted (if enabled) and remains asserted until the Interrupt Status register is accessed by the microprocessor with a read register command.

The computation of the total time of flight is performed by counting the number of full and fractional 4MHz clock cycles that elapsed between the launch start and a hit stop as shown in Figure 4.

Table 1. Two's Complement TOF DIFF

Conversion Example

REGISTER VALUE CONVERTER VALUE TOF DIFFInt TOF DIFFFrac TOF DIFF VALUE (hex) (hex) (ns) 7FFF FFFF 8,191,999.9962 001C 0403 7,003.9177 0001 00A1 250.6142 0000 0089 0.5226 0000 0001 0.0038 0000 0.0000 0000 FFFF FFFF -0.0038 FFFF FFC0 -0.2441 FFFE -480.2780 1432 FF1C 8001 -56,874.9962 8000 0000 -8,192,000.0000

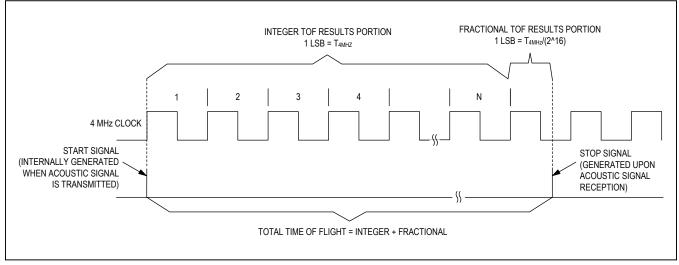


Figure 4.Start/Stop for Time-to-Digital Timing

Each TOF measurement result is comprised of an integer portion and a fractional portion. The integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the integer is 7FFFh or (2¹⁵-1) x t_{4MHz} or ~ 8.19 ms. The maximum size of the fraction is:

FFFFh or
$$\frac{2^{16} - 1}{2^{16}} \times t_{4MHz}$$
. or ~ 249.9961 ns.

Early Edge Detect

This early edge detect method of measuring the TOF of acoustic waves is used for all of the TOF commands including TOF_UP, TOF_DN, and TOF_DIFF. This method allows the MAX35103 to automatically control the input offset voltage of the receiver comparator so that it can provide advanced measurement accuracy. The input offset of the receiver comparator can be programmed with a range +127 LSBs if triggering on a positive edge and -127 LSBs if triggering on a negative edge, with 1 LSB = $V_{CC}/3072$. Separate input offset settings are available for the upstream received signal and the downstream received signal. The input offset for the upstream received signal is programmed using the C_OFFSETUP[6:0] bits in the TOF6 register. The input offset for the downstream received signal is programmed using the C_

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

OFFSETDN[6:0] bits in the TOF7 register. Once the first hit is detected, the time t1 equal to the width of the earliest detectable edge is measured. The input offset voltage is then automatically and immediately returned to a preprogrammed comparator offset value. This return offset value has a range of +127 LSBs to -128 LSBs in 1 LSB steps and is programmed into the C_OFFSETUPR[7:0] bits in the TOF6 register for the upstream received signal and programmed into the C_OFFSETDNR[7:0] bits in the TOF7 register. This preprogrammed comparator offset return value is provided to allow for common-mode shifts that can be present in the received acoustic wave.

The MAX35103 is now ready to measure the successive hits. The next selected wave that is measured is the t_2 wave. In the example in Figure 5, this is the 7th wave after the early edge detect wave. The selection of the t_2 wave is made with the T2WV[5:0] bits in the TOF2 register.

With reference to Figure 5, the ratio t_1/t_2 is calculated and registered for the user. This ratio allows determination of abrupt changes in flow rate, received signal strength, partially filled tube detection, and empty tube. It also provides noise suppression to prevent erroneous edge detection. Also, the ratio t_2/t_{ideal} is calculated and registered for the user. For this calculation, t_{ideal} is1/2 the period of launched pulse. This ratio adds confirmation that the t_2 wave is a strong signal, which provides insight into the common mode offset of the received acoustic wave.

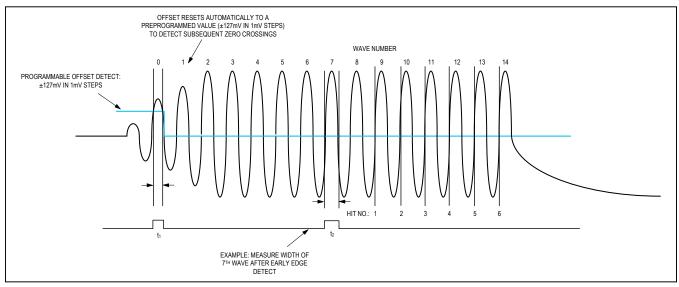


Figure 5. Early Edge Detect Received Wave Example

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

TOF Error Handling

Any of the TOF measurements can result in an error. If an error occurs during the measurement, all of the associated registers report FFFFh. If a TOF_DIFF is being performed, the TOF_DIFFInt and TOF_DIF_Frac registers report 7FFFh and FFFFh, respectively. The TOF_DIFF_AVG Results registers do not include the error measurement. If the measurement error is caused by the time measurement exceeding the timeout set by the TIMOUT[2:0] bits in the TOF2 register, then the TO bit in the Interrupt Status register is set and the INT pin asserts (if enabled).

Temperature Measurement Operations

A temperature measurement is a time measurement of the RC circuit connected to the temperature port device pins T1 through T4 and TC. The TC device pin has a driver to charge the timing capacitor. The ports that are measured and the order in which the measurement is performed is selected with the TP[1:0] bits in the Event Timing 2 register.

<u>Figure 6</u> depicts a 1000 Ω platinum RTD with a 100nF NPO COG 30ppm/°C capacitor. It shows two dummy cycles with 4 temperature port evaluation measurements and 4 real temperature port measurements. This occurs when setting the TP[1:0] bits in the Event Timing 2 register to 11b.

The dummy 1 and dummy 2 cycles represent preamble measurements that are intended to eliminate the dielectric absorption of the temperature measurement capacitor. These dummy cycles are executed using a RTD Emulation resistor of 1000Ω internal to the MAX35103. This dummy path allows the dielectric absorption effects of the capacitor to be eliminated without causing any of the RTDs to be unduly self-heated. The number of dummy measurements to be taken ranges from 0 to 7. This parameter is configured by setting the PRECYC[2:0] bits in the Event Timing 2 register.

Following the dummy cycles, an evaluation, TXevaluate, is performed. This measurement allows the MAX35103 to maximize power efficiency by evaluating the temperature of the RTDs with a coarse measurement prior to a real measurement. The coarse measurement provides an approximation to the TDC converter. During the real measurement, the TDC can then optimize its measurement parameters to use power efficiently. These evaluate cycles are automatically inserted according to the order of ports selected with the of the Temperature Port bits. The time from the start of one port's temperature measurement is set using with the PORTCYC[1:0] bits in the Event Timing 2 register.

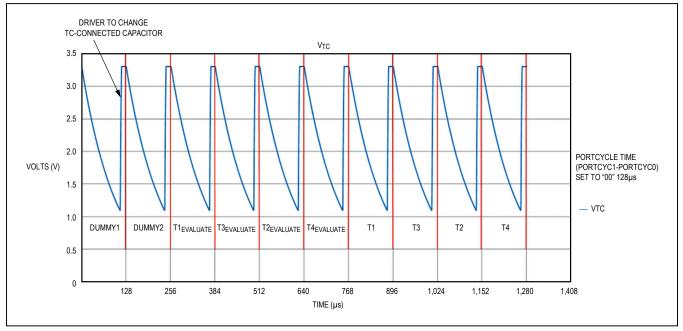


Figure 6. Temperature Command Execution Cycle Example

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Once all the temperature measurements are completed, the times measured for each port are reported in the corresponding TxInt and TxFrac Results registers. The TE bit in the Interrupt Status register is also set and the INT pin asserts (if enabled).

Actual temperature is determined by a ratiometric calculation. If T1 and T2 are connected to platinum RTDs and T3 and T4 are connected to the same reference resistor (as shown in the System Diagram), then the ratio of T1/ T3 = R_{RTD1}/R_{REF} and T2/T4 = R_{RTD2}/R_{REF} . The ratios R_{RTD1}/R_{REF} and R_{RTD2}/R_{REF} can be determined by the host microprocessor and the temperature can be derived from a look-up table of Temperature vs. Resistance for each of the RTDs utilizing interpolation of table entries if required.

Temperature Error Handling

The temperature measurement unit can detect open and/ or short-circuit temperature probes. If the resultant temperature reading in less than 8µs, then the MAX35103 writes a value of 0000h to the corresponding Results registers to indicate a short-circuit temperature probe. If the measurement process does not discharge the TC pin below the threshold of the internal temperature comparator within 2µs of the time set by the PORTCYC[1:0] bits in the Event Timing 2 register, then an open circuit temperature probe error is declared. The MAX35103 writes a value of FFFFh to the corresponding results registers to indicate an open circuit temperature probe, the TO bit in the Interrupt Status register is set, and the INT pin asserts (if enabled). If the temperature measurement error is caused by any other problems, then the MAX35103 writes a value of FFFFh to each of the temperature port results registers indicating that all of the temperature port measurements are invalid.

Event Timing Operation

The event timing mode of operation is an advanced feature that allows the user to configure the MAX35103 to perform automatic measurement cycles. This allows the host microcontroller to enter low-power mode and only awaken upon assertion of the MAX35103 INT pin (if enabled) when new measurement data is available. By using the TOF_DIFF and temperature commands and configuring the appropriate TOFx registers and the Event Timing registers, the event timing modes directs the MAX35103 to provide complete data for a sequence of measurements captured on a cyclical basis. There are three versions of the EVTMG commands.

- **EVTMG2**: Performs automatic TOF_DIFF measurements. The parameters and operation of the TOF measurement are described in the <u>Time-of-Flight</u> (*ToF*) Measurement Operations section.
- **EVTMG3:** Performs automatic Temperature measurements. The parameters and operation of the Temperature measurements are described in the *Temperature Measurement Operations* section.
- **EVTMG1:** Performs automatic TOF_DIFF and Temperature measurements.

Continuous Event Timing Operation

The MAX35103 can be configured to continue running event timing sequences at the completion of any sequence. If the ET_CONT bit in the Calibration and Control register is set, the currently executing EVTMGx command continues to execute until a HALT command is received by the MAX35103. If the ET_CONT bit is clear, automatic execution of event timing stops after the completion of a full sequence of measurements.

Continuous Interrupt Timing Operation

When operating in event timing mode, the \overline{INT} pin can be asserted (if enabled) either after each TOF or temperature measurement, or at the completion of the sequence of measurements. If the CONT_INT bit in the Calibration and Control register is set to a 1, then the \overline{INT} pin asserts (if enabled) at the completion of each TOF or temperature command. This allows the host microcontroller to interrogate the current event for accuracy of measurement. If the CONT_INT bit is set to a 0, then the \overline{INT} pin only asserts (if enabled) at the completion of a sequence of measurements. This allows the host microcontroller to remain in a low-power sleep mode and only wake-up upon the assertion of the \overline{INT} pin.

Error Handling During Event Timing Operation

During execution of event timing modes, any error that occurs during a TOF_DIFF or temperature measurement are handled as described in the corresponding error handling sections. Calibration can be executed during event timing operation, if programmed to do so with the calibration configuration bits in the Calibration and Control register. If a calibration error occurs, this is handled as described in the <u>Error Handling During Calibration</u> section. If any of these errors occur, the event timing operation does not terminate, but continues operation.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

When making TOF measurements in event timing mode, the MAX35103 provides additional data in the TOF_ Cycle_Count/TOF_Range register that can be used to check the validity of all of the TOF measurements. The TOF_Cycle_Count is the number of valid error-free TOF measurements that were recorded during an Event Timing Sequence. If a TOF error occurs, the TOF_Cycle_Count register will not be incremented. The TOF_Range is the range of all valid TOF measurements that were captured during a sequence.

When making temperature measurements in event timing mode, the MAX35103 provides additional data in the Temp_Cycle_Count register. This count increments after every valid error-free temperature measurement and can be used to check the validity of all of the temperature measurements. Also, the Temperature Average Results registers, TxAVG, are not updated with the error measurement if a temperature error occurs during event timing operation.

Event Timing Mode 2

The EVTMG2 command execution causes the TOF_DIFF command to be executed automatically with programmable repetition rates and programmable total counts as shown in Figure 7.

During execution of the EVTMG2 command, each TOF_ DIFF command execution cycle causes the MAX35103 to compute a TOF_DIFF measurement (AVGUP register minus AVGDN register) as well as the running average of TOF_DIFF measurements (TOFF_DIFF_AVG register). The setting of the 8XS and TDF[3:0] bits in the Event Timing 1 register selects the rate at which TOF_DIFF commands are executed. The setting of the TDM[4:0] bits in the Event Timing 1 register determines the number of TOF_DIFF measurements to be taken during the sequence.

Once all of the TOF_DIFF measurements in the sequence are captured, the TOF_DIFF_AVG register contains the average of the differences of the resultant AVGDN and AVGUP Results register content of each TOF_DIFF measurement. After the TOF_DIFF_AVG registers are updated, the TOF_EVTMG bit is set in the Interrupt Status register and the INT pin asserts (if enabled).

Event Timing Mode 3

The EVTMG3 command execution causes the temperature command to be executed automatically with programmable repetition rates and programmable total counts (Figure 9).

During execution of the EVTMG3 command, each Temperature command execution cycle computes the running average of the measurement of each temperature port. The results are provided in the Tx_AVGInt and TxAVGFrac Results registers.

The setting of the 8XS and TMF[5:0] bits in the Event Timing 1 register selects the rate at which temperature commands are executed. The setting of the TMM[4:0] bits in the Event Timing 2 register determines the number of temperature measurements to be taken during the sequence.

Once all of the temperature measurements in the sequence are captured Tx_AVGInt and TxAVGFrac Results registers contains the average of all the temperature measurements in the sequence. After these registers are updated, the Temp_EVTMG bit is set in the Interrupt Status register and the INT pin asserts (if enabled).

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

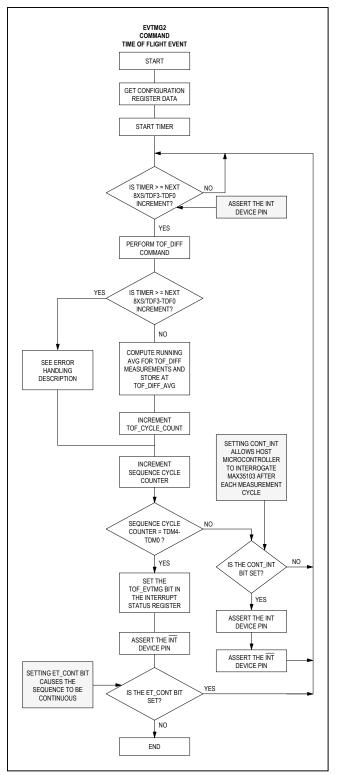


Figure 7. EVTMG2 Command

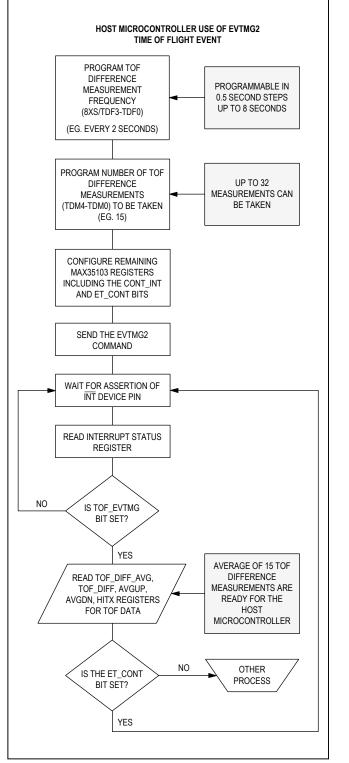


Figure 8. EVTMG2 Pseudo Code

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

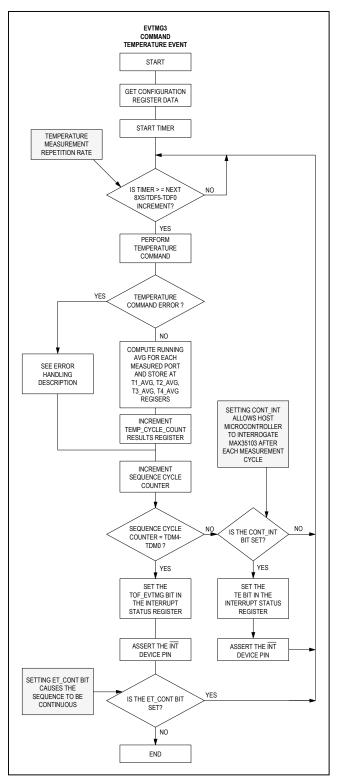


Figure 9. EVTMG3 Command

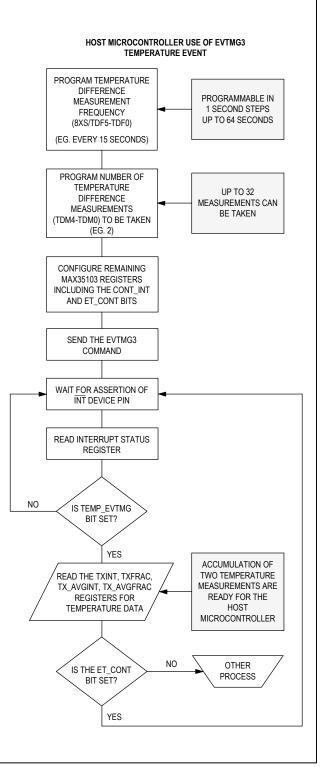


Figure 10. EVTMG3 Pseudo Code

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Event Timing Mode 1

The EVTMG1 command execution causes the TOF_DIFF command and the temperature command to be executed automatically with programmable repetition rates and programmable total counts. In essence, both the EVTMG2 and EVTMG3 commands are simultaneously executed in a synchronous manner.

Setting up the TOF measurements for automatic execution in event timing mode 1 is identical to setting these up for execution with event timing mode 2. Likewise, setting up the temperature measurements is identical to setting these up for execution using event timing mode 3.

If the TOF_DIF command repetition rate and the temperature command repetition rate cause both measurements to be required at the same time, the TOFF_DIF command takes precedent. Upon completion of the TOFF_DIFF command, the pending temperature command is executed (Figure 12).

Once all of the TOF_DIFF measurements in the sequence are complete, the TOF_EVTMG bit in the Interrupt Status register is set and the INT pin asserts (if enabled). Likewise, when all of the temperature measurements in the sequence are completed, the Temp_EVTMG bit in the Interrupt Status register is set and the INT pin asserts (if enabled). It should be noted that depending upon the selected rates and number of cycles, the TOF_DIFF and temperature measurements can complete their sequences at different times. This causes the INT pin to assert (if enabled) before both sequences are complete.

Calibration Operation

For more accurate results, calibration of the TDC can be performed. Calibration allows the MAX35103 to perform a calibration measurement that is based upon the 32.768kHz crystal, which is the most accurate clock in the system. This calibration is used when a ceramic oscillator is used in place of an AT-cut crystal for the 4MHz reference. The MAX35103 automatically generates START and STOP signals based upon edges of the 32.768kHz clock. The number of 32.768kHz clock periods that are used and then averaged are selected with the CAL_ PERIOD[3:0] bits in the Calibration and Control register.

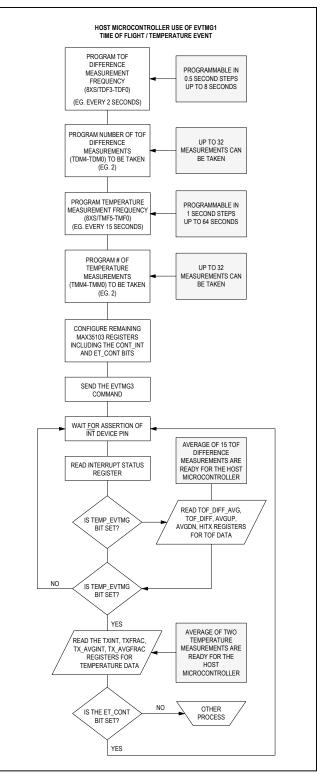


Figure 11. EVTMG1 Pseudo Code

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

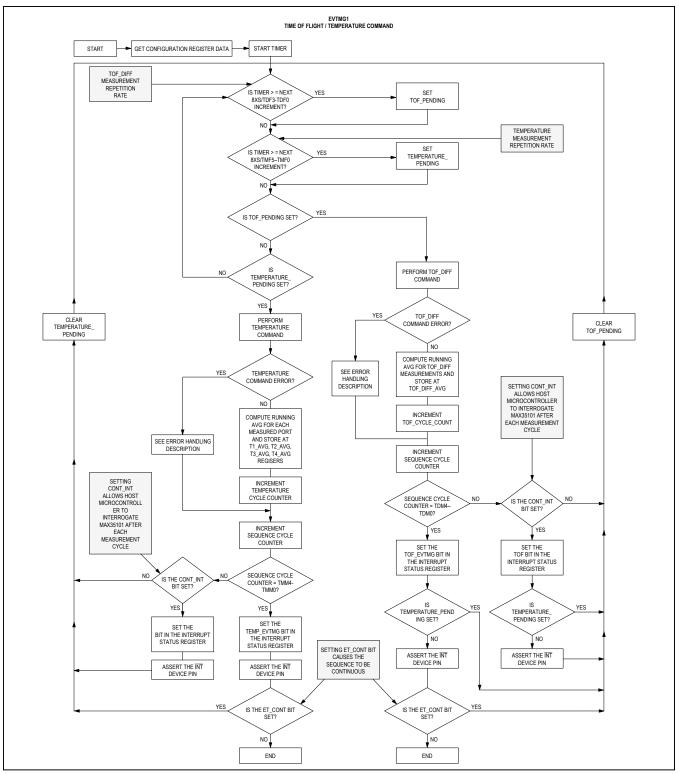


Figure 12. EVTMG1 Command

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

The TDC measures the number of 4MHz clock pulses that occur during the 32.768kHz pulses. The measured time of a 32.768kHz clock pulse is reported in the CalibrationInt and CalibrationFrac Results registers. These results can then be used as a gain factor for calculating actual timeto-digital converter measurement if the CAL_USE bit in the Event Timing 2 Register is set.

Following is a description of an example calibration. Each TDC measurement is a 15-bit fixed-point integer value concatenated with a 16-bit fractional value binary representation of the number of t_{4MHz} periods that contribute to the time result, the actual period of t_{4MHz} needs to be known. If the CAL PERIOD[3:0] bits in the Calibration and Control register are set to 6, then 6 measurements of 32.768kHz periods are measured by the TDC and then averaged. The expected measured value would be 30.5176µs/250ns = 122.0703125 t_{4MHz} periods. Assume that the 4MHz ceramic resonator is actually running at 4.02MHz. The TDC measurement unit would then measure 30.5176µs/248.7562ns = 122.6806641 t_{4MHz} periods and this result would be returned in the Calibration Results register. For all TDC measurements, a gain value of 122.0703125/122.6806641 = 0.995024876 would then be applied.

Calibration is performed at the following events:

- When the Calibration command is sent to the MAX35103. At the completion of this calibration, the CAL bit in the Interrupt Status register and the INT pin asserts (if enabled).
- During event timing operation, automatic calibrations can be performed before executing TOF or temperature measurements. This is selectable with the CAL_ CFG[2:0] bits in the Event Timing 2 register. Upon completion of an automatic calibration during event timing, the result is updated in the Calibration Results register, but the CAL bit in the Interrupt Status register is not set and the INT pin does not assert.

Error Handling During Calibration

Since calibration can be set to be automatic by configuring the CAL_CFG[2:0] bits in the Event Timing 2 register, any errors that occur during the Calibrate command stop the CalibrationInt and the CalibrationFrac Results registers from being updated with new calibration coefficients. The results for the previous Calibration data remain in these two registers and are used for scaling measured results. If the calibration error is caused by the internal calibration time measurement exceeding the time set by the TIMOUT[2:0] bits in the TOF2 register, then the TO bit in the Interrupt Status register is set and the $\overline{\text{INT}}$ pin asserts (if enabled).

RTC, Alarm, Watchdog, and Tamper Operation RTC Operation

The MAX35103 contains a real-time clock that is driven by a 32kHz oscillator. The time and calendar information is obtained by reading the appropriate register words. The time and calendar are set or initialized by writing the appropriate register words. The contents of the time and calendar registers are in the Binary-Coded Decimal (BCD) format. The clock/calendar provides hundredths of seconds, tenths of seconds, seconds, minutes, hours, day, date, month, and year information. The date at the end of the month is automatically adjusted for months with fewer than 31 days, including corrections for leap year valid up to 2100. The clock operates in either the 24-hour or 12-hour format with AM/PM indicator. The MAX35103 real-time clock can be programmed for either 12-hour or 24-hour formats. If using the 24-hour format, Bit6 (12 HR MODE) of the Mins Hrs register should be cleared to 0 and then Bit5 represents the 20-hour indicator. If using the 12-hour format, Bit6 should be set to 1 and Bit5 represents AM (if 0) or PM (if 1). The day-of-week register increments at midnight. Values that correspond to the day of week are user defined but must be sequential (i.e., if 0 equals Sunday, then 1 equals Monday, and so on). Illogical time and date entries result in undefined operation.

Alarm Operation

The MAX35103 real-time clock provides one programmable alarm. The alarm is activated when either the AM1 or AM2 bits in the Real-Time Clock register are set. Based upon these bits, an alarm can occur when either the minutes and/or hours programmed in the Alarm register match the current value in the Mins_Hrs register. When an alarm occurs, the AF bit in the Interrupt Status register is set and the INT device pin asserts (if enabled).

For proper alarm function, programming of the ALARM register HOURS bits must match the format (12- or 24-hour modes) used in the Mins Hrs register.

Watchdog Operation

The MAX35103 also contains a watchdog alarm. The Watchdog Alarm Counter register is a 16-bit BCD counter that is programmable in 10ms intervals from 0.01s to 99.99s. A seed value may be written to this register representing the start value for the countdown. The watchdog counter begins decrementing when the WD_EN bit in the RTC register is set.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

An immediate read of Watchdog Alarm Counter register returns the value just written. A read after a wait duration causes a value seed minus wait to be returned. For example if the seed value was 28.01s, an immediate read returns 28.01. A read after a 4s returns 24.01s. The value read out for any read operation is a snapshot obtained at the instant of a serial read operation.

A write operation to the Watchdog Alarm Counter register causes a reload with the newly written seed.

When the watchdog is enabled and a nonzero value is written into the Watchdog Alarm Counter register, the Watchdog Alarm Counter register decrements every 1/100s, until it reaches zero. At this point, the WF bit in the Real-Time Clock register is set and the WDO pin asserts low for typically 250ms. At the end of the pulse, the WDO pin becomes high impedance.

The WF flag remains set until cleared by writing WF to a logic 0 in the Real-Time Clock register. If the WF bit is cleared while the \overline{WDO} device pin is being held low, the \overline{WDO} device pin is immediately released to its highimpedance state. Writing a seed value of 0 does not cause the WF bit to assert.

Tamper Detect Operation

The MAX35103 provides a single input that can be connected to a device case switch and used for tamper detection. Upon detection of a case switch event the CSWA in the Control register and the <u>CSWI</u> bit in the Interrupt Status register is set and the <u>INT</u> device pin is asserted (if enabled).

Device Interrupt Operations

The MAX35103 is designed to optimize the power efficiency of a flow metering application by allowing the host microprocessor to remain in a low-power sleep mode, instead of requiring the microprocessor to keep track of complex real-time events being performed by the MAX35103. Upon completion of any command, the MAX35103 alerts the host microprocessor using the INT pin. The assertion of the INT pin can be used to awaken

the host microprocessor from its low power mode. Upon receiving an interrupt on the $\overline{\text{INT}}$ pin, the host microprocessor should read the Interrupt Status Register to determine which tasks were completed.

Interrupt Status Register

The interrupt status register contains flags for all for all commands and events that occur within the MAX35103. These flags are set when the event occurs or at the completion of the executing command. When the Interrupt Status Register is read, all asserted bits are cleared. If another interrupt source has generated an interrupt during the read, these new flags assert following the read.

INT Pin

The INT pin asserts when any of the bits in the Interrupt Status register are set. The INT pin remains asserted until the Interrupt Status register is read by the user and all bits in this register are clear. In order for the INT pin to operate, it must first be enabled by setting the INT_EN bit in the Calibration and Control register.

Serial Peripheral Interface Operation

Four pins are used for SPI-compatible communications: DOUT (serial-data out), DIN (serial-data in), \overline{CE} (chip enable), and SCK (serial clock). DIN and DOUT are the serial data input and output pins for the devices, respectively. The \overline{CE} input initiates and terminates a data transfer. SCK synchronizes data movement between the master (microcontroller) and the slave (MAX35103). The SCK, which is generated by the microcontroller, is active only when \overline{CE} is low and during opcode and data transfer to any device on the SPI bus. The inactive clock polarity is logic-low. DIN is latched on the falling edge of SCK. There is one clock for each bit transferred. Opcode bits are transferred in groups of eight, MSB first. Data bits are transferred in groups of sixteen, MSB first.

The serial peripheral interface is used to access the features and memory of the MAX35103 using an opcode/ command structure.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Opcode Commands

Table 2 shows the opcode/commands that are supported by the device.

Table 2.	Opcode	Commands
----------	--------	----------

GROUP	COMMAND	OPCODE FIELD (HEX)	ADDRESS FIELD
	TOF_Up	00h	N/A
	TOF_Down	01h	N/A
	TOF_Diff	02h	N/A
	Temperature	03h	N/A
	Reset	04h	N/A
	Initialize	05h	N/A
Execution Opcode	Transfer Configuration to FLASH	06h	N/A
Commands	EVTMG1	07h	N/A
	EVTMG2	08h	N/A
	EVTMG3	09h	N/A
	HALT	0Ah	N/A
	LDO_Timed	0Bh	N/A
	LDO_ON	0Ch	N/A
	LDO_OFF	0Dh	N/A
	Calibrate	0Eh	N/A
Register Opcode Commands	Read Register	B0h thru FFh. Each hex value represents the location of a single 16-bit register	N/A
	Write Register	30h thru 43h. Each hex value represents the location of a single 16-bit register	N/A
FLASH Opcode Commands	Read FLASH	90h	0000h - 1FFFh 8 Kbytes Even Only
	Write FLASH	10h	0000h - 1FFFh 8 Kbytes Even Only
	Block Erase FLASH	13h	0000h - 1FFFh

Execution Opcode Commands

The device supports several single byte opcode commands that cause the MAX35103 to execute various routines. All commands have the same SPI protocol sequence as shown in Figure 13. Once all 8 bits of the opcode are received by the MAX35103 and the \overline{CE} device pin is deasserted, the MAX35103 begins execution of the specified command as described in that Command's description.

TOF_UP Command (00h)

The TOF_UP command generates a single TOF measurement in the upstream direction. Pulses launch from the LAUNCH_UP pin and are received by the STOP_UP pin. The measured hit results are reported in the HITxUPInt and HITxUPFrac registers, with the calculated average of all the measured hits being reported in the AVGUPInt and AVGUPFrac register. The t_1/t_2 and $t_2/tideal$ wave ratios are reported in the WVRUP register. Once all these results are stored, then the TOF bit in the Interrupt Status register is set and the INT pin asserts (if enabled).

Note: The TOF_UP command yields a result that is only of use when used in conjunction with the TOF_DN command. Absolute TOF measurements include circuit delays and cannot be considered accurate.

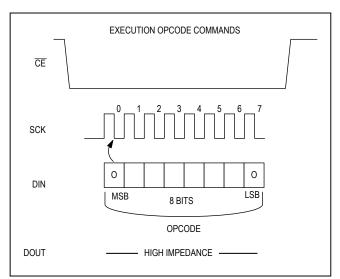


Figure 13. Execution Opcode Command Protocol

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

TOF_Down Command (01h)

The TOF_DOWN command generates a single TOF measurement in the downstream direction. Pulses launch from the LAUNCH_DN pin and are received by the STOP_DN pin. The measured hit results are reported in the HITxDnInt and HITxDnFrac registers, with the calculated average of all the measured hits being reported in the AVGDNInt and AVGDNFrac register. The t_1/t_2 and t_2/t_{ideal} wave ratios are reported in the WVRDN register. Once all these results are stored, then the TOF bit in the Interrupt Status register is set and the INT pin asserts (if enabled).

Note: The TOF_Down command yields a result that is only of use when used in conjunction with the TOF_UP command. Absolute TOF measurements include circuit delays and cannot be considered accurate.

TOF_DIFF Command (02h)

The TOF_DIFF command performs back-to-back TOF_ UP and TOF_DN measurements as required for a metering application. The TOF_UP sequence is followed by the TOF_DN sequence. The time between the start of the TOF_UP measurement and the start of the TOF_DN measurement is set by the TOF_CYC[2:0] bits in the TOF2 register. Upon completion of the TOF_DN measurement, the results of AVGUP minus AVGDN is computed and stored at the TOF_DIFFInt and TOF_DIFFFrac Results register locations. Once these results are stored, then the TOF bit in the Interrupt Status register is set and the INT pin asserts (if enabled).

Temperature Command (03h)

The temperature command initiates a temperature measurement sequence as described in the <u>Temperature</u> <u>Measurement Operations</u> section. The characteristics the temperature measurement sequence depends upon the settings in the Event Timing 1 register, and Event Timing 2 register. Once all the measurements are completed, the times measured for each port are reported in the corresponding TxInt and TxFrac Results registers. The TE bit in the Interrupt Status register also is set and the INT pin asserts (if enabled).

Reset Command (04h)

The reset command essentially performs the same function as a power-on reset (POR), and causes all of the Configuration registers to be set to their prior programmed values stored in flash and all of the Results registers and the Interrupt Status register to be cleared and set to zero.

Initialize Command (05h)

The initialize command must be executed after all configuration of the device is complete and the transfer configuration to flash command has been executed. The initialize command starts the time-to-digital converter so that TOF and temperature commands can be executed and also recalls all of the Configuration register settings from flash. The MAX35103 sets the INIT bit in the Interrupt Status register and asserts the INIT device pin (if enabled) to tell the host microprocessor that the initialize command has completed and the next desired command can be sent to the MAX35103.

Transfer Configuration to Flash Command (06h)

This command causes the Configuration register map to be transferred to flash for nonvolatile (NV) storage. The MAX35103 automatically turns on the LDO for the duration of this transfer. Upon device reset, the content of this flash restores the Configuration registers. This flash is not part of the 8KB array, and is reserved solely for the transfer configuration to the flash command. The MAX35103 sets the flash bit in the Interrupt Status register and asserts the INT device pin (if enabled) to tell the host microprocessor that the transfer configuration to the flash command has completed and the next command can be sent to the device.

EVTMG1 Command (07h)

The EVTMG1 command initiates the event timing mode 1 advanced automatic measurement feature. This timing mode performs automatic TOF_DIFF and Temperature measurements as described in the <u>Event Timing</u> <u>Operation</u> section. The duration of the automatic measurements depends upon the settings in the Event Timing 1 register, Event Timing 2 register, CONT_INT and ET_ CONT bits in the Calibration and Control register.

EVTMG2 Command (08h)

The EVTMG2 command initiates the event timing mode 2 advanced automatic measurement feature. This timing mode performs automatic TOF_DIFF measurements as described in the <u>Event Timing Operation</u> section. The duration of the automatic measurements depends upon the settings in the Event Timing 1 register, CONT_INT and ET_CONT bits in the Calibration and Control register.

EVTMG3 Command (09h)

The EVTMG3 command initiates the event timing mode 3 advanced automatic measurement feature. This timing mode performs automatic temperature measurements as described in the <u>Event Timing Operation</u> section. The duration of the automatic measurements depends upon the settings in the Event Timing 1 register, Event timing 2 register, CONT_INT and ET_CONT bits in the Calibration and Control register.

HALT Command (0Ah)

The HALT command is sent to the MAX35103 to stop any of the three EVTMG1/2/3 commands. All register data content is frozen and the SPI is then made available for access by the host microcontroller for commands, memory access, and register access. The HALT command takes time to execute. Since the EVTMGx commands are comprised of multiple TOF_DIFF and Temperature commands, the HALT command causes the MAX35103 to evaluate its own state and complete the currently executing TOF_DIFF or temperature command. Once the HALT command has completed, all registers update and the MAX35103 sets the halt bit in the Interrupt Status register and then asserts the INT device pin (if enabled). The host microprocessor reads the Interrupt Status register to determine the interrupt source.

LDO_Timed Command (0Bh)

To access the flash memory, the internal low-dropout voltage regulator that powers the flash circuitry must be enabled. By sending the LDO Timed command to the MAX35103 prior to the desired flash access command (read, write, block erase), the internal regulator is enabled and powers the flash circuitry. The LDO bit is set in the Interrupt Status register and the INT device pin asserts (if enabled) when the internal regulator has been turned on and is stable which takes approximately tSTABLE. The host microprocessor, upon detection of the asserted INT device pin, should read the Interrupt Status register LDO bit to determine that the internal regulator is stable and the flash is now ready to be accessed. The internal regulator remains enabled for a continuous period until the \overline{CE} device pin is deasserted after any flash command (read, write, block erase). The LDO_Timed command is used in place of the LDO ON command when a data access to the flash is required in a short burst. This minimizes SPI access since the LDO OFF command is not required to be sent to the MAX35103 to turn off the internal regulator.

LDO_ON Command (0Ch)

To access the flash memory, the internal low-dropout voltage regulator that powers the flash circuitry must be enabled. By sending the LDO ON command to the MAX35103 prior to the desired flash access command (read, write, block erase), the internal regulator is enabled and powers the flash circuitry. The LDO bit is set in the Interrupt Status register and the INT device pin asserts (if enabled) when the internal regulator has been turned on and is stable which takes approximately tSTABLE. The host microprocessor, upon detection of the asserted INT device pin, should read the Interrupt Status register LDO bit to determine that the internal regulator is stable and the flash is now ready to be accessed. The internal regulator remains enabled for a continuous period until the LDO OFF command is received by the MAX35103. The LDO ON command is generally used when the host microprocessor needs to perform multiple-word writes to the MAX35103 since multiple-word writes require that the \overline{CE} device pin be toggled after every word of data written. The LDO ON command prevents the LDO from automatically disabling itself after each transition of the CE device pin.

LDO_OFF Command (0Dh)

To access the flash memory, the internal low-dropout voltage regulator that powers the flash circuitry must be enabled. By sending the LDO_OFF command to the MAX35103, the internal regulator is disabled and the Interrupt Status register LDO bit is cleared. The INT device pin is not asserted. The LDO_OFF command is used in conjunction with the LDO_ON command.

Calibrate Command (0Eh)

The calibrate command performs the calibration routine as described in the calibration operation section. When the calibrate command has completed the measurement, the Calibration Results register contains the measured 32kHz period measuremnt value, the MAX35103 sets the calibration bit in the Interrupt Status register and then asserts the INT device pin (if enabled). The host microprocessor reads the Interrupt Status register to determine the interrupt source and then read the Calibration Results register to be able to calculate the 4MHz ceramic oscillator gain factor.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Register Opcode Commands

To manipulate the register memory, there are two commands supported by the device: Read Register and Write register. Each register accessed with these commands is 16 bits in length. These commands are used to access all sections of the memory map including the RTC and Watchdog registers, Configuration registers, Conversion Results registers, and Status registers. The Conversion Results registers and the Interrupt Status register of the Status registers are all read only.

Read Register Command

The opcode must be clocked into the DIN device pin before the DOUT device pin produces the register data. The SPI protocol sequence is shown in Figure 14.

The read register command can also be used to read consecutive addresses. In this case, the data bits are continuously delivered in sequence starting with the MSB of the data register that is addressed in the opcode, and continues with each SCK rising edge until the \overline{CE} device pin is deasserted as shown in Figure 15. The address counter automatically increments.

Write Register Command

This command applies to all writable registers. See the <u>Register Memory Map</u> for more detail. The SPI protocol sequence is shown in <u>Figure 16</u>.

The write register command can also be used to write consecutive addresses. In this case, the data bits are continuously received on the DIN device pin and bound for the initial starting address register that is addressed in the opcode. The address counter automatically increments after each 16 bits of data if the SCK device pin is continually clocked and the \overline{CE} device pin remain asserted as shown in Figure 17.

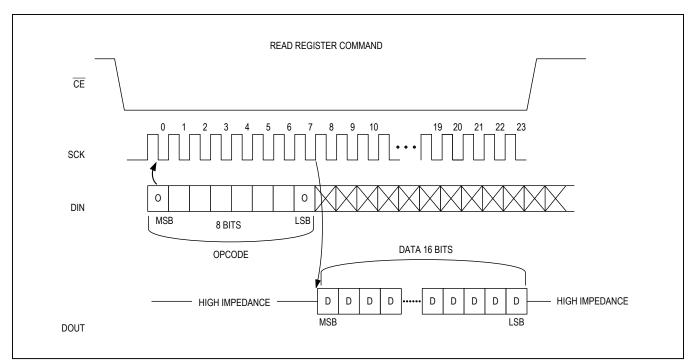


Figure 14. Read Register Opcode Command Protocol

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

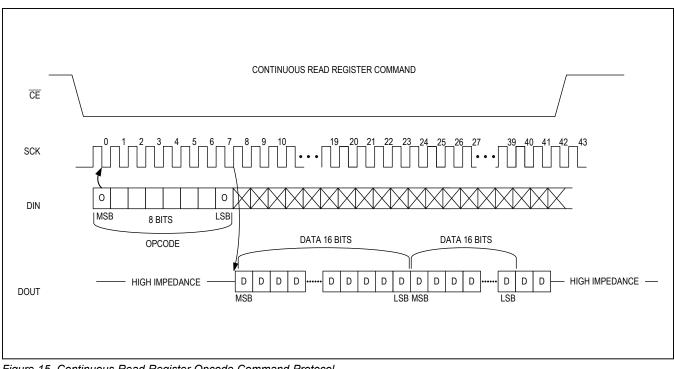
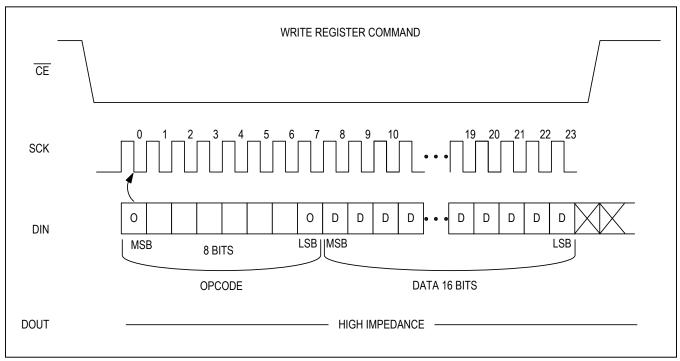


Figure 15. Continuous Read Register Opcode Command Protocol





Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

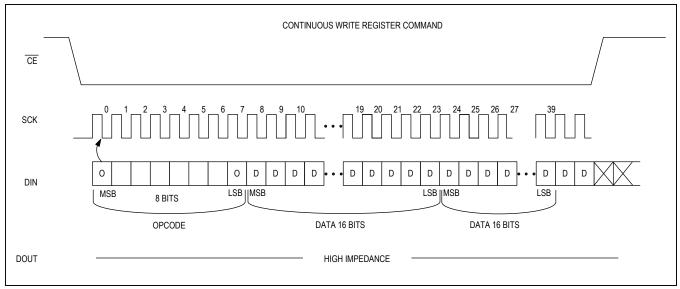


Figure 17. Continuous Write Register Opcode Command Protocol

Register Memory Map

These registers are accessed by the read register command and the Write Register command: "X" represents a reserved bit. Following a reset, all configuration variables are recalled from flash. The factory-stored flash default value for all configuration registers except TOF1 is 0000h. The factory-stored flash configuration for TOF1 is 0010h. After a transfer to configuration to flash command, the new user configuration data is recalled from flash after a reset.

The RTC register, Results registers, Interrupt Status, and Control registers are all 0000h following a reset.

Table 3. Register Memory Map

READ OPCODE	WRITE OPCODE	NAME				BITS	6[15:8]							BITS	6[7:0]			
RTC AND	WATCHDOG	REGISTERS																
B0h	30h	Seconds	Tent	hs of Sec	onds		Hu	ndredth S	econds			10 Se	conds			Seco	nds	
B1h	31h	Mins_Hrs	1	10-Minutes Minutes				0	12hr	20hr/AM	/PM	10hr Hours						
B2h	32h	Day_Date		Day						10-D	ate		I	Dat	e			
B3h	33h	Month_ Year		10-Month Month						10-ነ	'ear			Yea	ır			
B4h	34h	Watchdog Alarm Counter	Tent	Tenths of Seconds Hundredths of Seconds							10 Se	conds		Seconds				
B5h	35h	Alarm	1	0-Minute	s			Minute	s		0	12hr	20hr/AM	/PM	10hr	Ala	arm Hours	
	RATION REG	ISTERS pred from flash	n memory (upon devi	ce reset.	These reo	gisters are	e written t	o flash m	emory upor	the issua	ance of th	e transfer o	configurat	ion to flas	sh comma	nd.	
B6h	36h									Rese	erved							
B7h	37h									Rese	erved							
B8h	38h	TOF1	PL7	PL6	PL5	PL4	PL3	PL2	PL1	PL0	DPL3	DPL2	DPL1	DPL0	STOP _POL	x	CT1	СТО
B9h	39h	TOF2	STOP 2	STOP 1	STOP 0	T2WV 5	T2WV 4	T2WV 3	T2WV 2	T2WV 1	T2WV0	TOF_ CYC2	TOF_ CYC1	TOF_ CYC0	EN_U P_DN	TIM OUT2	TIM OUT1	TIM OUT0
BAh	3Ah	TOF3	х	х	Hit1 WV5	Hit1 WV4	Hit1 WV3	Hit1 WV2	Hit1 WV1	Hit1 WV0	х	х	Hit2 WV5	Hit2 WV4	Hit2 WV3	Hit2 WV2	Hit2 WV1	Hit2 WV0
BBh	3Bh	TOF4	х	х	Hit3 WV5	Hit3 WV4	Hit3 WV3	Hit3 WV2	Hit3 WV1	Hit3 WV0	х	х	Hit4 WV5	Hit4 WV4	Hit4 WV3	Hit4 WV2	Hit4 WV1	Hit4 WV0
BCh	3Ch	TOF5	х	х	Hit5 WV5	Hit5 WV4	Hit5 WV3	Hit5 WV2	Hit5 WV1	Hit5 WV0	х	х	Hit6 WV5	Hit6 WV4	Hit6 WV3	Hit6 WV2	Hit6 WV1	Hit6 WV0
BDh	3Dh	TOF6	C_OF FSET RUP7	C_OF FSET RUP6	C_OF FSET RUP5	C_OF FSET RUP4	C_OF FSET RUP3	C_OF FSET RUP2	C_OF FSET RUP1	C_OF FSET RUP0	C_OF FSET UP7	C_OF FSET UP6	C_OF FSET UP5	C_OF FSET UP4	C_OF FSET UP3	C_OF FSET UP2	C_OF FSET UP1	C_OF FSET UP0
BEh	3Eh	TOF7	C_OF FSET RDN7	C_OF FSET RDN6	C_OF FSET RDN5	C_OF FSET RDN4	C_OF FSET RDN3	C_OF FSET RDN2	C_OF FSET RDN1	C_OF FSET RDN0	C_OF FSET DN7	C_OF FSET DN6	C_OF FSET DN5	C_OF FSET DN4	C_OF FSET DN3	C_OF FSET DN2	C_OF FSET DN1	C_OF FSET DN0
BFh	3Fh	Event Timing 1	TDF3	TDF2	TDF1	TDF0	TDM4	TDM3	TDM2	TDM1	TDM0	TMF5	TMF4	TMF3	TMF2	TMF1	TMF0	8XS

MAX35103

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ OPCODE	WRITE OPCODE	NAME				BITS	[15:8]							BITS	[7:0]			
C0h	40h	Event Timing 2	TMM4	ТММЗ	TMM2	TMM1	тммо	Cal_ Use	Cal_ AUTO	Cal_ CFG1	Cal_ CFG0	TP1	TP0	PREC YC2	PREC YC1	PREC YC0	PORT CYC1	PORT CYC0
C1h	41h	TOF Measure- ment Delay	DLY15	DLY14	LY13	DLY12	DLY11	DLY10	DLY9	DLY8	DLY7	DLY6	DLY5	DLY4	DLY3	DLY2	DLY1	DLY0
C2h	42h	Calibration and Control	х	x	х	х	CMP_ EN	CMP_ SEL	INT_ EN	ET_ CONT	CONT _INT	CLK_ S2	CLK_ S1	CLK_ S0	Cal_P eriod3	Cal_P eriod2	Cal_P eriod1	Cal_P eriod0
C3h	43h	Real-Time Clock	х	x	х	х	x	x	х	х	x	32K_ BP	32K_ EN	EOSC	AM2	AM1	WF	WD_ EN
CONVERS	ION RESULT	S REGISTER	S															÷
C4h	Read Only		WVRUP															
C5h	Read Only		Hit1UpIr	nt														
C6h	Read Only		Hit1UpF	rac														
C7h	Read Only		Hit2UpIr	nt														
C8h	Read Only		Hit2UpF	rac														
C9h	Read Only		Hit3UpIr	nt														
CAh	Read Only		Hit3UpF	rac														
CBh	Read Only		Hit4UpIr	nt														
CCh	Read Only		Hit4UpF	rac														
CDh	Read Only		Hit5UpIr	nt														
CEh	Read Only		Hit5UpF	rac														
CFh	Read Only		Hit6UpIr	nt														

MAX35103

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ OPCODE	WRITE OPCODE	NAME	BITS[15:8]	BITS[7:0]
D0h	Read Only		Hit6UpFrac	
D1h	Read Only		AVGUPInt	
D2h	Read Only		AVGUPFrac	
D3h	Read Only		WVRDN	
D4h	Read Only		Hit1DnInt	
D5h	Read Only		Hit1DnFrac	
D6h	Read Only		Hit2DnInt	
D7h	Read Only		Hit2DnFrac	
D8h	Read Only		Hit3DnInt	
D9h	Read Only		Hit3DnFrac	
DAh	Read Only		Hit4DnInt	
DBh	Read Only		Hit4DnFrac	
DCh	Read Only		Hit5DnInt	
DDh	Read Only		Hit5DnFrac	
DEh	Read Only		Hit6DnInt	
DFh	Read Only		Hit6DnFrac	
E0h	Read Only		AVGDNInt	

MAX35103

READ OPCODE	WRITE OPCODE	NAME	BITS[15:8]	BITS[7:0]
E1h	Read Only		AVGDNFrac	
E2h	Read Only		TOF_DIFFInt	
E3h	Read Only		TOF_DIFFFrac	
E4h	Read Only		TOF_Cycle_Count	
E5h	Read Only		TOF_DIFF_AVGInt	
E6h	Read Only		TOF_DIFF_AVGFrac	
E7h	Read Only		T1Int	
E8h	Read Only		T1Frac	
E9h	Read Only		T2Int	
EAh	Read Only		T2Frac	
EBh	Read Only		T3Int	
ECh	Read Only		T3Frac	
EDh	Read Only		T4Int	
EEh	Read Only		T4Frac	
EFh	Read Only		Temp_Cycle_Count	
F0h	Read Only		T1_AVGInt	
F1h	Read Only		T1_AVGFrac	

MAX35103

READ OPCODE	WRITE OPCODE	NAME				BITS	S[15:8]							BITS	[7:0]			
F2h	Read Only		T2_AVO	GInt														
F3h	Read Only		T2_AVO	GFrac														
F4h	Read Only		T3_AV0	GInt														
F5h	Read Only		T3_AV0	GFrac														
F6h	Read Only		T4_AVO	GInt														
F7h	Read Only		T4_AVG	GFrac														
F8h	Read Only		Calibrat	tionInt														
F9h	Read Only		Calibrat	tionFrac														
FAh	Read Only		Reserve	ed														
FBh	Read Only		Reserve	ed														
FCh	Read Only		Reserve	ed														
FDh	Read Only		Reserve	ed														
STATUS R	REGISTERS																	
FEh	Read Only	Interrupt Status	то	AF	х	TOF	TE	LDO	TOF_ EVTMG	TEMP_ EVTMG	FLASH	CAL	HALT	CSWI	INIT	POR	х	x
FFh	Read Only	Control	x	х	х	x	х	x	AFA	CSWA	х	х	x	х	х	х	х	х

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

RTC and Watchdog Register Descriptions

Table 4. RTC Seconds Register

WF	RITE OPCODE 30h	R	EAD OPCODE B0h	FLA	SH STORED No		DEFAULT VALUE 0000h			
Dit	45	44	40		44	10	0			
Bit	15	14	13	12	11	10	9	8		
Name		Tenths of	of Seconds			Hundredths	of Seconds			
Bit	7	6	5	4	3	2	1	0		
Name	0		10 Seconds			Seco	onds			
					-					
BIT	NAI	ME	DESCRIPTION							
15:12	Tenths of	Seconds	Range 0 to 9							
11:8	Hundredths	of Seconds	Range 0 to 9							
7	0 This bit always			returns 0						
6:4	10 Se	cond	Range 0 to 5							
3:0	Seco	onds	Range 0 to 9							

Table 5. RTC Mins_Hrs Register

WR	ITE OPCODE 31h		READ OPCODE B1h	FLA	SH STORED		DEFAULT VALUE 0000h				
Bit	15	14	13	12	11	10	0	0			
Name	0					_	10 9 8 Minutes				
Bit	7	6	5	4	3	2	1	0			
Name	0	12/24	20HR/AM/PM	10HR		Но	ours				
BIT	NAME				DESCRIP	TION					
15	0		This bit always returns 0								
14:12	10 Minut	10 Minutes Range 0 to 5									
11:8	Minute	Minutes Range 0 to 9									
7	0 This bit always retur			ns 0							

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 5. RTC Mins_Hrs Register (continued)

BIT	NAME	DESCRIPTION
6	12/24	1 = 12-hour mode 0 = 24-hour mode
5	20HR/AM/PM	In 12-hour mode 1 = PM 0 = AM In 24-hour mode: 20-hour digit
4	10HR	Range 0 to 1
3:0	Hours	Range 0 to 9

Table 6. RTC Day_Date Register

WR	WRITE OPCODE 32h		READ OPCODE B2h	FL	ASH STORED No		DEFAULT VALUE 0000h				
D ''			10	40		40					
Bit	15	14	13	12	11	10	9	8			
Name	0 0		0	0	0		Day				
Bit	7	6	5	4	3	2	1	0			
Name	0	0	10	Date		D	ate				
	11										
BIT	NAME				DESCRIPTI	ON					
15:11	0		These bits always re	These bits always return 0							
10:8	Day		Range 0 to 7								
7:6	0 The		These bits always re	These bits always return 0							
5:4	10 Date		Range 0 to 3								
3:0	Date		Range 0 to 9								

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 7. RTC Month_Year Register

WR	ITE OPCODE 33h		READ OPCODE B3h	FLAS	SH STORED No		DEFAULT VALUE 0000h		
Bit	15	14	13	12	11	10	9	8	
Name	0	0	0	10 Month	Month				
				l					
Bit	7	6	5	4	3	2	1	0	
Name			10 Year			Ye	ear		
BIT	NAME		DESCRIPTION						
15:13	0		These bits always r	eturn 0					
12	10 Mont	h	Range 0 to 1						
11:8	Month		Range 0 to 9						
7:4	10 Yea	r	Range 0 to 9						
3:0	Year		Range 0 to 9						

Table 8. Watchdog Alarm Counter Register

WR	ITE OPCODE 34h	R	EAD OPCODE FI B4h		SH STORED No		DEFAULT VALUE 0000h	
Bit	15	14	13	12	11	10	9	8
Name		Tenths	of Seconds			Hundredths	of Seconds	
Bit	7	6	5	4	3	2	1	0
Name		10 5	Seconds			Sec	onds	
BIT	NAI	ME		DESCRIPTION				
15:12	Tenths of	Seconds	Range 0 to 9					
11:8	Hundredths	of Seconds	Range 0 to 9					
7:4	10 Se	cond	Range 0 to 9					
3:0	Seco	nds	Range 0 to 9					

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 9. Alarm Register

WR	RITE OPCODE 35h		F	READ OPCODE B5h	FLA	SH STORED No		DEFAULT VALUE 0000h			
Bit	15	14	4 13 12			11	10	9	8		
Name	X			10 Minutes			Min	utes			
Bit	7	6	5 4			3 2 1					
Name	X 12/2		4	20HR/AM/PM	10HR		Hc	ours			
BIT	NAME			DESCRIPTION							
15	Х		Res	served							
14:12	10 Minut	es	Rar	nge 0 to 5							
11:8	Minutes	6	Range 0 to 9								
7	Х		Res	served							
6	12/24	12/24 1 = 12-hour mode 0 = 24-hour mode									
5	20HR/AM/PM In 12-hour mode 1 = PM 0 = AM In 24-hour mode: 20-hour		nour digit								
4	10HR		Rar	nge 0 to 1							
3:0	Hours		Rar	nge 0 to 9							

Configuration Register Descriptions

Table 10. TOF1 Register

WRITE OPCODEREAD OPCODEFLASH STOREDFAC38hB8hYes						FACTORY	FACTORY-STORED FLASH VALUE 0010h			
Bit	15	14	13	12	11	10	9	8		
Name	PL7	PL6	PL5	PL4	PL3	PL2	PL1	PL0		
Bit	7	6	5	4	3	2	1	0		
Name	DPL3	DPL2	DPL1	DPL0	STOP_POL	Х	CT1	CT0		

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 10. TOF1 Register (continued)

BIT	NAME	DESCRIPTION								
15:8	PL[7:0]	from the pulse launch PL[7:0] is set to 00h,	Pulse Launcher Size : This is a hex value that defines the number of pulses that will be launched from the pulse launcher during transmission. The range of this hex value is 00h to FFh. When PL[7:0] is set to 00h, the Pulse Launcher is disabled. Up to 127 pulses can be launched. When PL7 is set, the pulse count is clamped at 127.							
		used to drive the Puls for the internal clock clock. The range of th	se Launch signal. T reference. The inte nis hex value is 1h of 0h is not support	lue that defines the divider ratio The 4MHz external reference oso rnal reference clock is first divid to Fh, resulting in a range of div ted and should not be programn PL[3:0])	cillator is used as the source ed by 2 to produce a 2MHz ision from ÷2 to ÷16 of the					
7:4	DPL[3:0]		DPL[3:0]	PULSE L	AUNCH FREQUENCY					
	Di [[0.0]		0000b		RESERVED					
			0001b		1MHz					
			0002b		666kHz					
			1110b 1111b		133.33kHz 125kHz					
3	STOP_POL	signal received on the internal TDC time cou	e STOP_UP and S unt on the rising slo TOP_DN device pi	sensitivity of the STOP_UP and TOP_DN device pins will generators ope of this signal if this bit is set ns will generate a stop condition this bit is set to 1.	ate a stop condition for the to 0. The signal received on					
2	X	Reserved								
				tted for charging the external bia e analog receiver/comparator. It						
				DESCR	IPTION					
1:0	CT[1:0]	CT1	CT2	32kHz CLOCK CYCLES (decimal)	TYPICAL TIME (μs)					
		0	0	2	61					
		0	1	4	122					
		1	0	8	244					
		1	1	16	488					

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 11. TOF2 Register

WR	ITE OPCODE 39h		RE	AD OPCODE B9h	-	l STORED Yes	RED FACTORY-STORED FLASH V/ 0000h		ASH VALUE		
Bit	15	14	4	13	12	11	10	9	8		
Name	STOP2	STC	OP1 STOP0		T2WV5	T2WV4	T2WV3	T2WV2	T2WV1		
Bit	7	6	;	5	4	3	2	1	0		
Name	T2WV0 TOF_C		CYC2	TOF_CYC1	TOF_CYC0	Х	TIMOUT2	TIMOUT1	TIMOUT0		
BIT	NAME					DESCRIP	TION				
			Stop	top Hits: These bits set the number of stop hits to be expected and measured.							
			STOP2		STOP1		STOP0	DESC	DESCRIPTION		
			0		0	0		1	Hit		
				0	0		1	2	Hits		
15:13	STODIA.	.01		0	1		0	3	Hits		
15.15	STOP[2:	л 		0	1		1	4	Hits		
				1 0			0	5	Hits		
			1		0	0		6	Hits		
				1	1		0	6	Hits		
				1	1		1	6	Hits		
			Wave Selector for t ₂ : These bits determine the wave number for which t ₂ is measured. To ensure measurement accuracy, the first wave measurable after the early edge detect is wave 2. Waves are numbered as depicted in Figure 5.								
				T2WV[5:0	0] (decimal)		DES	SCRIPTION			
12:7	T2WV[5:	D]		0 thr	ough 2			Wave 2			
					3			Wave 3			
					4			Wave 4			
				5 thro	ough 63		Wave	5 through 63			

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 11. TOF2 Register (continued)

		TOF measurements. If TOF_DN and is applic	i is the start-to-start tim able only for the TOF_ DF of the acoustic path	ne of automatic exec DIFF command. It i a exceeds the progra	successive executions of cution of the TOF_UP and the s based upon the 32.768kHz ammed start-to-start time in g is 000b.
				DESCRIPTI	ON
		TOF_CYC[2:0]	32kHz CLOCK CYCLES (decimal)	TYPICAL TIME	4MHz ON BETWEEN TOF_ UP and TOF_DOWN
6:4	TOF_CYC[2:0]	000b	0	0µs	Yes
		001b	4	122µs	Yes
		010b	8	244µs	Yes
		011b	16	488µs	Yes
		100b	24	732µs	Yes
		101b	32	976µs	Yes
		110b	546	16.65ms	No
		111b	655	19.97ms	No
3	Х	Reserved			
		time, the TO bit in the Additionally, any of the invalid.	t2 or Hit1 through Hit Interrupt Status registe Conversion Results r	6 of the received sig er is set and the INT egisters read FFFF	nal does not occur in this pin is asserted (if enabled). n if the data for that register is
		TIMOUT2	TIMOUT1	TIMOUTO	DESCRIPTION (µs)
2:0	TIMOUT[2:0]	0	0	0	128
2.0		0	0	0	256
		0	1	1	512
		1	0	0	2048
		1	0	1	4096
			ÿ	· · · · · · · · · · · · · · · · · · ·	
		1	1	0	8192

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 12. TOF3 Register

WRITE OPCODE 3Ah		R	EAD OPCODE BAh	FLAS	FLASH STORED Yes		FACTORY-STORED FLASH VALUE 0000h		
Bit	15	14	13	12	11	10	9	8	
Name	Х	х	HIT1WV5	HIT1WV4	HIT1WV3	HIT1WV2	HIT1WV1	HIT1WV0	
Bit	7	6	5	4	3	2	1	0	
Name	Х	Х	HIT2WV5	HIT2WV4	HIT2WV3	HIT2WV2	HIT2WV1	HIT2WV0	
BIT	NAME				DESCRIPT	ON			

BIT	NAME	DESCR	IPTION			
15:14	Х	Reserved				
13:8		Hit1 Wave Select: These bits select the wave number for which the Hit1 stop time is measured. Wave numbers are depicted in Figure 5. The Hit1 wave select value must be least 1 greater than the wave selected for t_2 , which is configured in the TOF2 register. For example, if the wave selector for t_2 is set to wave number 7, then the Hit1 wave select m set to delect wave number 8 or greater. The earliest wave for which Hit1 can be measured wave 3.				
13.0	HIT1WV[5:0]	HIT1WV[5:0] (decimal)	DESCRIPTION			
		0 through 3	Wave 3			
		4	Wave 4			
		5	Wave 5			
		6 through 63	Wave 6 through 63			
7:6	Х	Reserved				
		Hit2 Wave Select: These bits select the wave measured. Wave numbers are depicted in Figur least 1 greater than the Hit1 wave select value. measure wave number 9, then the Hit2 wave se greater. The earliest wave for which Hit2 can be	e 5. The Hit2 wave select value must be at For example, if Hit1 wave select value is set to lect must be set to detect wave number 10 or			
5:0	HIT2WV[5:0]	HIT2WV[5:0] (decimal)	DESCRIPTION			
		0 through 4	Wave 4			
		5	Wave 5			
		6	Wave 6			
		7 through 63	Wave 7 through 63			

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 13. TOF4 Register

WR	ITE OPCODE 3Bh		RE	AD OPCODE BBh	FLAS	H STORED Yes	FACTOR	Y-STORED FL 0000h	ASH VALUE	
				1						
Bit	15	14	1	13	12	11	10	9	8	
Name	Х	X X		HIT3WV5	HIT3WV4	HIT3WV3	HIT3WV2	HIT3WV1	HIT3WV0	
Bit	7	6		5	4	3	2	1	0	
Name	Х	Х		HIT4WV5	HIT4WV4	HIT4WV3	HIT4WV2	HIT4WV1	HIT4WV0	
BIT						DESCRIPT	ON			
15:14	Х		Rese	rved						
			Hit3 Wave Select: These bits select the wave number for which the Hit3 stop time is measured. Wave numbers are depicted in Figure 5. The Hit3 wave select value must be at least 1 greater than the Hit2 wave select value. For example, if the Hit2 wave select value is set to measure wave number 10, then the Hit3 wave select must be set to detect wave number 11 or greater. The earliest wave for which Hit3 can be measured is wave 5.							
13:8	HIT3WV[5:0]		HIT3WV[5	:0] (decimal)] (decimal)		DESCRIPTION		
				0 thr	ough 5		Wave 5			
					6			Wave 6		
					7		Wave 7			
			8 through 63 Wave 8 through 63							
				8 thro	bugn 63		Wav	e 8 through 63		

measured. Wave numbers are depicted in Figure 5. The Hit4 wave select value must be at least 1 greater than the Hit3 wave select value. For example, if the Hit3 wave select value is set to measure wave number 11, then the Hit4 wave select must be set to detect wave number 12 or greater. The earliest wave for which Hit4 can be measured is wave 6.

5:0	HIT4WV[5:0]	HIT4WV[5:0] (decimal)	DESCRIPTION
		0 through 6	Wave 6
		7	Wave 7
		8	Wave 8
		9 through 63	Wave 9 through 63

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 14. TOF5 Register

WR	ITE OPCODE 3Ch		READ OPCODE BCh	FLAS	H STORED Yes	ED FACTORY-STORED FLASH VALU 0000h					
Bit	15	14	13	12	11	10	9	8			
Name	X X		HIT5WV5	HIT5WV4	HIT5WV3	HIT5WV2	HIT5WV1	HIT5WV0			
Bit	7	6	5	4	3	2	1	0			
Name	X	Х	HIT6WV5	HIT6WV4	HIT6WV3	HIT6WV2	HIT6WV1	HIT6WV0			
BIT	NAME		DESCRIPTION								
15:14	X		Reserved								
			Hit5 Wave Select : These bits select the wave number for which the Hit5 stop time is measured. Wave numbers are depicted in Figure 5. The Hit5 wave select value must be at least 1 greater than the Hit4 wave select value. For example, if the Hit4 wave select value is set to measure wave number 12, then the Hit5 wave select must be set to detect wave number 13 or greater. The earliest wave for which Hit5 can be measured is wave 7.								
13:8	HIT5WV[5:0] [HIT5WV[5:	0] (decimal)		DE	SCRIPTION				
			0 thre	ough 7			Wave 7				
		Ī		8			Wave 8				
				9							
		Ī	10 through 63 Wave 10 through 63					3			
1			Reserved								

measured. Wave numbers are depicted in Figure 5. Hit6 wave select value must at least 1 greater than the Hit5 wave select value. For example, if Hit5 wave select value is set to measure wave number 13, then the Hit6 wave select must be set to detect wave number 14 or greater. The earliest wave for which Hit6 can be measured is wave 8.

5:0	HIT6WV[5:0]	HIT6WV[5:0] (decimal)	DESCRIPTION
		0 through 8	Wave 8
		9	Wave 9
		10	Wave 10
		11 through 63	Wave 11 through 63

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 15. TOF6 Register

WF	RITE OPCODE 3Dh		RE	AD OPCODE BDh	FLAS	H STORED Yes	ED FACTORY-STORED FLASH VALUE 0000h			
	1									
Bit	15	1	4	13	12	11	10	9	8	
Name	C_OFFSET UPR7	T C_OFFSET UPR6		C_OFFSET UPR5	C_OFFSET UPR4	C_OFFSET UPR3	C_OFFSET UPR2	C_OFFSET UPR1	C_OFFSET UPR0	
Bit	7	6		5	4	3	2	1	0	
Name	X C_OFFSET UP6			C_OFFSET UP5	C_OFFSET UP4	C_OFFSET UP3	C_OFFSET UP2	C_OFFSET UP1	C_OFFSET UP0	
BIT	NAME		DESCRIPTION							
15:8	C_OFFSET [7:0]	UPR	prografter f after f scale return	7Fh thr	comparator offs 1, is detected. e present at the setting, where C n Offset Voltag	et is returned t The actual offse V _{CC} pins. The OFFSETUPR	o a common-mo et return voltage e following form t is a two's-comp <u>1152+C_OFFS</u> 3072 OFI 12	ode voltage aut is dependent u ula defines the plement numbe	omatically upon and comparator	
7	Х		Rese			I				

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 15. TOF6 Register (continued)

BIT	NAME	DESC	RIPTION
6:0	C_OFFSETUP [6:0]	voltage for the analog receiver comparator from the early edge wave, t_1 . The actual common- the voltage present at the V _{CC} pins. When the STOP_POL bit in the TOF1 register is the zero crossing of the received acoustic wave When the STOP_POL bit in the TOF1 register is the zero crossing of the received acoustic wave The following formulas define the comparator of	ode voltage is dependent upon and scales with s set to zero indicating a rising edge detection of e, then the comparator offset is a positive value. s set to one indicating a falling edge detection of e, then the comparator offset is a negative value. ffset voltage setting $Voltage = V_{CC} \times \frac{(1152 + C_{OFFSETUP})}{3072}$
		C_OFFSETUP[6:0]	OFFSET (LSBs)
		00h through 7Fh	0 through 127

Table 16. TOF7 Register

WRITE OPCODE REAL 3Eh			AD OPCODE FLASH STORED BEh Yes				FACTORY-STORED FLASH VALUE 0000h		
15	14	13	12	11	10	9	8		
lame I – I –		C_OFFSET DNR5	C_OFFSET DNR4	C_OFFSET DNR3	C_OFFSET DNR2	C_OFFSET DNR1	C_OFFSET DNR0		
7	6	5	4	3	2	1	0		
x	C_OFFSET DN6	C_OFFSET DN5	C_OFFSET DN4	C_OFFSET DN3	C_OFFSET DN2	C_OFFSET DN1	C_OFFSET DN0		
	3Eh 15 C_OFFSET DNR7 7	3Eh 15 14 C_OFFSET C_OFFSET DNR7 DNR6 7 6 X C_OFFSET	3EhBEh151413C_OFFSET DNR7C_OFFSET DNR6C_OFFSET DNR5765XC_OFFSET C_OFFSETC_OFFSET	3EhBEh15141312C_OFFSET DNR7C_OFFSET DNR6C_OFFSET DNR5C_OFFSET DNR47654XC_OFFSET C_OFFSETC_OFFSET C_OFFSETC_OFFSET	3Eh BEh Yes 15 14 13 12 11 C_OFFSET DNR7 C_OFFSET DNR6 C_OFFSET DNR5 C_OFFSET DNR4 C_OFFSET DNR3 7 6 5 4 3 X C_OFFSET C_OFFSET C_OFFSET C_OFFSET	3EhBEhYes151413121110C_OFFSET DNR7C_OFFSET DNR6C_OFFSET DNR5C_OFFSET DNR4C_OFFSET DNR4C_OFFSET DNR3C_OFFSET DNR2765432XC_OFFSET C_OFFSETC_OFFSET C_OFFSETC_OFFSET C_OFFSETC_OFFSET C_OFFSETC_OFFSET C_OFFSET	3Eh BEh Yes 0000h 15 14 13 12 11 10 9 C_OFFSET C_OFFSET C_OFFSET C_OFFSET C_OFFSET C_OFFSET C_OFFSET C_OFFSET DNR3 DNR2 DNR1 7 6 5 4 3 2 1 X C_OFFSET C_OFFSET C_OFFSET C_OFFSET C_OFFSET C_OFFSET		

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 16. TOF7 Register (continued)

BIT	NAME	DESC	RIPTION			
15:8	C_OFFSETDNR [7:0]	Comparator Return Offset Downstream: When the MAX35103 is measuring the t ₂ wave, the programmed receive comparator offset is returned to a common-mode voltage automatically after the early edge, t ₁ is detected. The actual offset return voltage is dependent upon and scales with the voltage present at the V _{CC} pins. The following formula defines the comparator return offset voltage setting, where C_OFFSETDNR is a two's-complement number: Comparator Return Offset Voltage = $V_{CC} \times \frac{(1152+C_OFFSETDNR)}{3072}$ where 1 LSB = $\frac{V_{CC}}{3072}$				
		C_OFFSETDNR[7:0]	OFFSET (LSBs)			
		7Fh through 01h	127 through 1			
		00h	0			
		80h through FFh	-128 through -1			
7	Х	Reserved				
6:0	C_OFFSETDN [6:0]	with the voltage present at the V_{CC} pins. When the STOP_POL bit in the TOF1 register is the zero crossing of the received acoustic wave When the STOP_POL bit in the TOF1 register is the zero crossing of the received acoustic wave The following formulas define the comparator of	The front-end. This comparator offset is used to non-mode voltage is dependent upon and scales a set to zero indicating a rising edge detection of then the comparator offset is a positive value. If the the comparator offset is a negative value. If then the comparator offset is a negative value. If the the comparator offset is a negative value.			

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 17. Event Timing 1 Register

Bit Name Bit Name	15 TDF3 7	14 TDF2	13	READ OPCODE FLASH STORED BFh Yes			D FACTORY-STORED FLASH VALUE 0000h					
Bit Name	TDF3	TDF2	10	12	11	10	9	8				
Name	7		TDF1	TDF0	TDM4	TDM3	TDM2	TDM1				
Name	7											
		6	5	4	3	2	1	0				
DIT	TDM0	TMF5TMF4TMF3TMF2TMF1TMF0										
BIT	NAME											
		TOF_DIFF n	DESCRIPTION TOF Difference Measurement Frequency: Along with 8XS, these bits define the rate at which TOF_DIFF measurements are executed when the EVTMG1 or EVTMG2 command is executed. Rate = 0.5s + (TDF[3:0] x 0.5s)									
	TDF[3:0]		TDF[3:0] (d	decimal)		RATE (8XS = 0)	RATE	(8XS = 1)				
15:12			0			0.5s	0	.0625s				
			1			1.0s	0	0.1250s				
			14			7.5s	0	.9476s				
			15			8.0s	1	.0000s				
11:7	TDM[4:0]	Cycles = 1+	TDM[4:0] (CYCLES 1						
			1			2						
			30			31						
			31			32						
		temperature measureme	cycle measurer	ments. It is a st ecuted when th	art-cycle to sta	bits define the tim rt-cycle time durat EVTMG3 commar	ion at which	temperature				
			TMF[5:0] (d	decimal)		RATE (8XS = 0)	RATE	(8XS = 1)				
6:1	TMF[5:0]		0			1s	().125s				
			1			2s	(.250s				
			62			63s	7	7.875s				
			63			64s						

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 18. Event Timing 2 Register

W	RITE OPCODE 40h	RE	AD OPCODE C0h	FLAS	FLASH STORED Yes		FACTORY-STORED FLASH VALUE 0000h			
Bit	15	14	13	12	11	10	9	8		
Name	TMM4	TMM3	TMM2	TMM1	TMM0	CAL_USE	CAL_CFG2	CAL_CFG1		
Bit	7	6	5	4	3	2	1	0		
Name	CAL_CFG0	TP1	TP0	PRECYC2	PRECYC	I PRECYC0	PORTCYC1	PORTCYC0		
BIT	NAME		DESCRIPTION							
		Temperature Measurements: These bits define the number of temperature measurements be executed when the EVTMG1 or EVTMG3 command is executed. Cycles = 1+ TMM[4:0]								
			TMM[4:0]	(decimal)			CYCLES			
15:11	TMM[4:0]			0		1				
				1			2			
				80 81			31 32			
10	CAL_USE	Calibrati of data v	onInt and Calibra	ationFrac registence The EVTMG com	ers during me mands. All tir	AX35103 to use the asurement, average measurement, average measurements and.	aging and accur	nulation		
			Calibration Configuration: These bits define the point in the EVTMGx cycle/sequence where automatic calibration command is executed.							
						DESCRIPTIC	N			
		C	AL_CFG[2:0]	DURING	DURING EVTMGX SEQUENCES, AUTOMATIC EXECUTION OF THE CALIBRATE COMMAND OCCURS AT:					
		000	b through 011b	Autocalibra	ation disable	d				
9:7	CAL_CFG[2:0]		100b		0	h TOF_DIFF cycle h temperature cycle				
			101b	-	The beginning of each TOF_DIFF cycle The beginning of each temperature sequence					
			110b			TOF_DIFF seque				
			111b	-	-	TOF_DIFF seque				

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 18. Event Timing 2 Register (continued)

BIT	NAME			DES	CRIPTION		
					of temperature ports equence in which the		
_		TP1	TP0		DESCRIP	TION	
6:5	TP[1:0]	0	0	Measure ports T1	and T3		
		0	1	Measure ports T2	and T4		
		1	0	Measure ports T1	, T3, and T2		
	1	1	Measure ports T1	, T3, T2, and T4			
		preamble for I	reducing diele	ctric absorption of the	re used to set the nu ne temperature measurence as defined by	surement	capacitor. Each cycle
		PRECY	′C2	PRECYC1	PRECYC	0	DESCRIPTION
		0		0	0		0 dummy cycle
		0		0	1		1 dummy cycles
4:2	PRECYC[2:0]	0		1	0		2 dummy cycles
		0		1	1		3 dummy cycles
		1		0	0		4 dummy cycles
		1		0	1		5 dummy cycles
		1		1	0		6 dummy cycles
		1		1	1		7 dummy cycles
		temperature p	ort measuren	nents. It is a start-to-	e interval between s start time. These bit See the <i>Temperatu</i>	s also def	
1:0	PORTCYC[1:0]	PO	RTCYC1	PC	ORTCYC0	DE	ESCRIPTION (µs)
			0		0		128
			0		1		256
			1		0		384
			1		1		512

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 19. TOF Measurement Delay Register

WRITE OPCODE 41h			REA	AD OPCODE C1h	FLAS	H STORED Yes	FACTORY-STORED FLASH VAL 0000h		
Bit Name	15 DLY15	14 DLY		13 DLY13	12 DLY12	11 DLY11	10 DLY10	9 DLY9	8 DLY8
Bit Name	7 DLY7	6 DL`		5 DLY5	4 DLY4	3 DLY3	2 DLY2	1 DLY1	0 DLY0
BIT	NAME					DESCRIPTIO	N		
15:0	DLY[15:0]	4l ai co ha	This is hexadecimal value ranging from 0000h to FFFFh (decimal 0 to 65535). It is a multiple 4MHz crystal period (250ns). Settings less than 0012h are reserved and should not be used. analog comparator driven by the STOP_UP and STOP_DN device pins does not generate a scondition until this delay, counted from the internally generated start pulse for the acoustic wa has expired. This delay applies to early edge detect wave. Care must be taken to set the TIM bits in the TOF2 register so that a timeout interrupt does not occur before this delay expires.						

Table 20. Calibration and Control Register

WF	WRITE OPCODE 42h			AD OPCODE C2h				FACTORY-STORED FLASH VALUE 0000h		
	1 .						1	-		
Bit	15		14	13	12	11	10	9	8	
Name	X		x	Х	Х	CMP_EN	CMP_SEL	INT_EN	ET_CONT	
							· · ·			
Bit	7		6	5	4	3	2	1	0	
Name	CONT_INT	CL	K_S2	CLK_S1	CLK_S0	CAL_ PERIOD3	CAL_ PERIOD2	CAL_ PERIOD1	CAL_ PERIOD0	
BIT	NAME					DESCRIPTIO	N			
15:12	Х		Reserved							
11	CMP_EN		Comparator/UP_DN Output Enable: 1 = CMP_OUT/UP_DN output device pin is enabled. 0 = CMP_OUT/UP_DN output device pin is driven low.							

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 20. Calibration and Control Register (continued)

BIT	NAME			DESCRI	PTION					
10	CMP_SEL	pin and is only us 1 = CMP_EN: Th 0 = UP_DN: The High Output: U	sed when CMP_E le output monitors output monitors t pstream measure	N = 1. the receiver from the launch direction ment (Launch_U	ts the output function of the C at end comparator output. on of the pulse launcher. P to STOP_UP) _DN to STOP_DN)	MP_OUT/UP_DN				
9	INT_EN	Interrupt Enable the INT pin.	Interrupt Enable: This bit, when set, enables the INT pin. All interrupt sources are wire-ORed to the INT pin.							
8	ET_CONT	command to com This bit, when cle • The cur measur • The cur measur • The cur	measurements cycles.							
7	CONT_INT	assert the INT pin allows the host m hit data. When this bit is c	Continuous Interrupt: This bit, when set, causes the currently executing EVTMGx command to assert the INT pin (if enabled) after every TOF_DIFF or temperature measurement cycle. This allows the host microprocessor to interrogate the current event for accuracy of measurements and hit data. When this bit is cleared, the currently executing EVTMGx command interrupt generation behavior is controlled only by the setting of the ET_CONT bit.							
		-			erval that the MAX35103 wai measurements of time or ten	-				
					DESCRIPT	ION				
		CLK_S2	CLK_S1	CLK_S0	32kHz CLOCK CYCLES	TYPICAL TIME				
		0	0	0	16	488µs				
		0	0	1	48	1.46ms				
6:4	CLK_S[2:0]	0	1	0	96	2.93ms				
		0	1	1	128	3.9ms				
		1	0	0	168	5.13ms				
			1 0 1 4MHz oscillator on continuously							
		1	0	1	4MHz oscillator on continu					
		1	0 1	1 0	4MHz oscillator on continu 4MHz oscillator on continu	ously				

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 20. Calibration and Control Register (continued)

BIT	NAME	DESCRIPTION						
		4MHz Ceramic Oscillator Calibration Period: These bits define the number of 32.768kHz oscillator periods to measure for determination of the 4MHz ceramic oscillator period. 32kHz clock cycles = 1+ CAL_PERIOD[3:0]						
			DESCR	IPTION				
3:0	CAL_PERIOD[3:0]	CAL_PERIOD[3:0] (decimal)	32kHz CLOCK CYCLES (decimal)	32kHz CLOCK CYCLES (µs)				
0.0		0	1	30.5				
		1	2	61				
		14	15	457.7				
		15	16	488.0				

Table 21. Real-Time Clock Register

WRITE OPCODE 43h		RE	READ OPCODE C3h		FLASH-STORED Yes		FACTORY-STORED FLASH VALUE 0000h		
Bit	15	14	13	12	11	10	9	8	
Name	Х	X	Х	Х	Х	Х	Х	Х	
Bit	7	6	5	4	3	2	1	0	
Name	Х	32K_BP	32K EN	EOSC	AM1	AM0	WF	WD_EN	

BIT	NAME	DESCRIPTION
15:7	X	Reserved
6	32K_BP	32kHz Bypass: This bit, when set, allows an external CMOS-level 32.768kHz signal to be applied to the 32KX1 device pin. The internal 32.768kHz oscillator is bypassed and the external signal is driven into the MAX35103 core.
5	32K_EN	32kHz Clock Output Enable: This bit enables the 32KOUT device pin to drive a CMOS-level square wave representation of the 32kHz crystal.
4	EOSC	Enable Oscillator: This active-low bit when set to logic 0 starts the real-time clock oscillator. When this bit is set to logic 1, the oscillator is stopped.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 21. Real-Time Clock Register (continued)

BIT	NAME			DESCRIPTION						
		the AM1 or AM2 to the alarm sett INT device pin is	Alarm Control: The MAX35103 contains a time-of-day alarm. The alarm is activated when eith the AM1 or AM2 bits are set. When the RTC's hours or minutes value increments to a value equ to the alarm settings in Alarm registers, the AF bit in the Interrupt Status register is set and the INT device pin is asserted (if enabled) and remains asserted until the Interrupt Status register is accessed by the microprocessor with a read register command.							
3:2	AM[1:0]	AM1	AM0	ALARM FUNCTION						
		0	0	No alarm						
		0	0 1 Alarm when minutes match							
		1	0	Alarm when hours match						
		1	1	Alarm when hours and minutes match						
1	WF	to a zero to clear	Watchdog Flag : This bit is set when the watchdog counter reaches zero. This bit must be written to a zero to clear the bit. Writing this bit to a zero when the \overline{WDO} pin is asserted low releases the \overline{WDO} pin to its inactive high-impedance state.							
0	WD_EN	1 = Watchdog tir	Watchdog Enable: 1 = Watchdog timer is enabled. 0 = Watchdog time is disabled, and the WDO pin is high impedance.							

Status Register Descriptions

Table 22. Interrupt Status Register

	WRITE OPCODE Read Only		READ OPCODE FEh		FLASH STORED No		DEFAULT VALUE 0000h		
Bit	15	14	13	12	11	10	9	8	
Name	то	AF	x	TOF	TE	LDO	TOF_ EVTMG	TEMP_ EVTMG	
				·			·		
Bit	7	6	5	4	3	2	1	0	
Name	FLASH	CAL	HALT	CSWI	INIT	POR	Х	Х	
	s register is read on formation.	nly and bits	are self-clearing u	upon a read to	this register. Se	e the Device In	terrupt Operati	ons section	
BIT	NAME				DESCRIPTIC	N			
15	ТО		Timeout: The TO bit is set if any one of the t_1 , t_2 , Hit1 through Hit6, or temperature measurements do not occur within the associated timeout window.						
14	AF		Alarm Flag: Set when the RTC's hours or minutes value increments to a value equal to the settings in Alarm registers.						
13	Х	Reser	ved						

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 22. Interrupt Status Register (continued)

BIT	NAME	DESCRIPTION
12	TOF	Time of Flight: Set when the TOF_UP, TOF_DN, or TOF_DIFF command has completed. During execution of The EVTMG1 or EVTMG2 command, this bit is set and the INT pin asserts (if enabled) upon completion of each of the cycles of the event defined by the TOF difference measurements setting if the CONT_INT bit in the Calibration and Control register has been set.
11	TE	Temperature: Set when the temperature command has completed. During execution of The EVTMG1 or EVTMG3 command, this bit is set and the INT pin asserts (if enabled) upon completion of each of the cycles of the event defined by the temperature measurements setting if the CONT_INT bit in the Calibration and Control register has been set.
10	LDO	Internal LDO Stabilized: Set when the internal low-dropout regulator is turned on by either the LDO_Timed or LDO_ON and has stabilized. Once asserted, a flash command can be sent to the MAX35103.
9	TOF_EVTMG	Event Timing TOF Completed: Set when either the EVTMG1 or EVTMG2 commands have completed its last TOF_DIFF measurement cycle. This indicates that the data in the TOF_DIFF, TOF_DIFF_AVG, AVGUP, and AVGDN Results registers is valid.
8	TEMP_EVTMG	Event Timing Temperature Completed: Set when the EVTMG1 or EVTMG3 commands have completed its last temperature measurements. This indicates that the data in the T1, T2, T3, T4, T1_AVG, T2AVG, T3AVG, and T4_AVG Results registers is valid.
7	FLASH	Flash Ready: Set when the flash memory is ready to be accessed. During execution of any command that requires write access to the flash memory (write flash, transfer configuration to flash, block erase, initialize), the SPI port is inactive and should not be exercised. The host microprocessor is interrupted by the assertion of the INT pin (if enabled) once the command has been completed and the SPI of the MAX35103 is available for access.
6	CAL	Calibrate: Set after completion of the Calibrate command when the command is manually sent by the host microprocessor. When calibration occurs as a result of the setting of the Cal_Use, Cal_AUTO and Cal_CFGx bits in the Event Timing 2 register and the MAX35103 is automatically executing calibration commands as required during execution of any of the EVTMGx commands, this bit is not set.
5	HALT	HALT: Set when the HALT command has completed.
4	CSWI	Case Switch: Set when a high logic level is detected on the CSW device pin.
3	INIT	Initialize: Set when the Initialize command has completed.
2	POR	Power-On-Reset: Set when the MAX35103 has been successfully powered by application of V_{CC} . Upon application of power, the SPI port becomes inactive until this bit has been set.
1:0	Х	Reserved

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 23. Control Register

WRITE OPCODE FFh		RI	EAD OPCODE 7Fh	FLAS	SH STORED No		DEFAULT VALUE 0000h		
Bit	15	14	13	12	11	10	9	8	
Name	Х	Х	Х	Х	Х	Х	AFA	CSWA	
Bit	7	6	5	4	3	2	1	0	
Name	Х	X	Х	X	X	X	Х	Х	

BIT	NAME	DESCRIPTION
15:10	Х	Reserved
9	AFA	Alarm Flag Arm: This bit is set when the RTC's hours and/or minutes value matched the alarm settings in the RTC register. This bit is set at the same time as the AF bit in the Interrupt Status register. After resetting the RTC alarm settings, a 0 must be written to this bit to rearm the RTC Alarm. This bit can only be written to a 0.
8	CSWA	Case Switch Arm: This bit is set when the CSW pin detects a logic-high, indicating the MAX35103 has detected a tamper condition. This bit is set at the same time as the CSWI bit in the Interrupt Status register. Once set, this bit must be written to a 0 to rearm the case switch detection. The case switch detection must be rearmed before the CSWI interrupt can be set again. This bit can only be written to a 0.
7:0	Х	Reserved

Conversion Results Register Descriptions

The devices conversion results registers are all read-only volatile SRAM. Values are not stored in the flash memory and the POR value for all registers is 0000h.

READ ONLY ADDRESS	NAME	DESCRIPTION									
			Bit 15 through Bit 8 holds the 8-bit value of the pulse width ratio $(t_1 \div t_2)$ for the upstream measurement. Each bit is weighted as follows:								
		BIT 15	BIT 14	BIT 13	BIT 12	BIT 11	BIT 10	BIT 9	BIT 8		
		1	0.5	0.25	0.125	0.0625	0.03125	0.015625	0.0078125		
C4h	WVRUP		period of th					where t _{ide} al is asurement. Ea			
		BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0		
		1	0.5	0.25	0.125	0.0625	0.03125	0.015625	0.0078125		
		The maxir	num value o	of each of th	ese ratios is	s 1.9921875					
C5h	Hit1UPInt	a binary re	epresentatio	on of the nur		Iz periods th	at contribute	This integer p to the time re			
C6h	Hit1UPFrac	representa	16-bit fractional value of the first hit in the upstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .								
C7h	Hit2UPInt	is a binary	representa	tion of the r		MHz periods	that contribu	ion. This integ te to the time			
C8h	Hit2UPFrac	binary rep	resentation		_{Iz} period qua	-		fractional por ion. The maxi			
C9h	Hit3UPInt	a binary re	epresentatio	on of the nur		Iz periods th	nat contribute	. This integer to the time re			
CAh	Hit3UPFrac	representa	16-bit fractional value of the third hit in the upstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .								
CBh	Hit4UPInt	a binary re	epresentatio	on of the nur		_{Iz} periods th	at contribute	n. This intege to the time re			
CCh	Hit4UPFrac	representa	16-bit fractional value of the fourth hit in the upstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t _{4MHz} .								

Table 24. Conversion Results Registers Description

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ ONLY ADDRESS	NAME				DES	CRIPTION				
CDh	Hit5UPInt	a binary re	15-bit fixed-point integer value of the fifth hit in the upstream direction. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .							
CEh	Hit5UPFrac	representa	16-bit fractional value of the fifth hit in the upstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .							
CFh	Hit6UPInt	a binary re	epresentatio	on of the nur		z periods that		. This integer to the time re		
D0Fh	Hit6UPFrac	representa	16-bit fractional value of the sixth hit in the upstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .							
D1h	AVGUPInt	integer po	15-bit fixed-point integer value of the average of the hits recorded in the upstream direction This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .							
D2h	AVGUPFrac	16-bit fractional value of the average of the hits recorded in the upstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or $(2^{16} - 1)/2^{16} \times t_{4MHz}$.								
		Bit 15 through Bit 8 holds the 8 bit value of the pulse width ratio (t_1/t_2) for the downstream measurement. Each bit is weighted as follows:								
		BIT 15	BIT 14	BIT 13	BIT 12	BIT 11	BIT 10	BIT 9	BIT 8	
		1	0.5	0.25	0.125	0.0625	0.03125	0.015625	0.0078125	
D3h	WVRDN		of the puls					here t _{ideal} is e ment. Each bi		
		BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0	
		1	0.5	0.25	0.125	0.0625	0.03125	0.015625	0.0078125	
		The maxin	num value o	of each of th	ese ratios is	1.9921875.	·			
D4h	Hit1DNInt	a binary re	epresentatio	on of the nur		z periods tha		on. This intege to the time re		
D5h	Hit1DNFrac	binary rep	resentation		_{Iz} period qua			ractional porti ion. The maxi		
D6h	Hit2DNInt	is a binary	representa	ation of the n		_{/Hz} periods t		ection. This in te to the time		

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ ONLY ADDRESS	NAME	DESCRIPTION
D7h	Hit2DNFrac	16-bit fractional value of the second hit in the downstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
D8h	Hit3DNInt	15-bit fixed-point integer value of the third hit in the downstream direction. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .
D9h	Hit3DNFrac	16-bit fractional value of the third hit in the downstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
DAh	Hit4DNInt	15-bit fixed-point integer value of the fourth hit in the downstream direction. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .
DBh	Hit4DNFrac	16-bit fractional value of the fourth hit in the downstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
DCh	Hit5DNInt	15-bit fixed-point integer value of the fifth hit in the downstream direction. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x $t_{4M}H_z$.
DDh	Hit5DNFrac	16-bit fractional value of the fifth hit in the downstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or $(2^{16} - 1)/2^{16} \times t_{4MHz}$.
DEh	Hit6DNInt	15-bit fixed-point integer value of the sixth hit in the downstream direction This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .
DFh	Hit6DNFrac	16-bit fractional value of the sixth hit in the downstream direction. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
E0h	AVGDNInt	15-bit fixed-point integer value of the average of the hit times recorded in the downstream direction. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or ($2^{15} - 1$) x t_{4MHz} .
E1h	AVGDNFrac	16-bit fractional value of the average of the hit times recorded in the downstream direction. This fractional portion is a binary representation of one period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or $(2^{16} - 1)/2^{16} \times t_{4MHz}$.

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ ONLY ADDRESS	NAME				DESCR					
E2h	TOF_DIFFInt	recorded in This intege maximum s	16-bit fixed-point two's-complement integer portion of the difference of the averages for the hits recorded in both the upstream and downstream directions. It is computed as: AVGUP - AVGDN This integer represents the number of t _{4MHz} periods that contribute to computation. The maximum size of the integer is 7FFFh or (2 ¹⁵ – 1) x t _{4MHz} . The minimum size of this integer is 8000h or -2 ¹⁵ x t _{4MHz} .						ne	
E3h	TOF_ DIFFFrac	recorded ir representa	16-bit fractional portion of the two's complement difference of the averages for the hits recorded in both the upstream and downstream directions. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or $(2^{16} - 1)/2^{16} \times t_{4MHz}$.							
		integer that during exe TOF_Rang	t indicates th cution of eith	ne range of vaner of the EV	alid error-free TMG1 or EV	OF_Range. ⁻ e TOF_DIFF TMG2 comm launch perio	measureme ands. The m	nts that were naximum valu	made le of	
		BIT 15	BIT 14	BIT 13	BIT 12	BIT 11	BIT 10	BIT 9	BIT 8	
		MSB	~	TO	F_Range 8-b	oit binary inte	ger		LSB	
		The formulas to calculate the range and resolution of the TOF_Range DPL[3:0] bit setting are shown below: Maximum range (μ s) = DPL[3:0] + 1 Resolution = Maximum range/2								
		DPL[3:0]		LAUNCH FREQUENCY			M RANGE s)	RESOLUTION (ns)		
		000	01b	1MHz		2		7.8	175	
	TOF_Cycle_	000)2b	666.6kHz		3		11.7185		
E4h	Count									
	/TOF_Range	111	l0b	133.3kHz		15		58.59375		
		11	11b	125kHz		1	6	62	2.5	
		binary integ EVTMG2 of been totale AVGFrac a command i error check bits in the I in the Inter Cycle Court	ger that indic commands h ad for the pur nd TOF_DIF is executed l king, once th Event Timing rupt Status r	eates the num as executed. rpose of aver F_AVGInt re by either the e complete r g 1 register h egister causi e equal to the	nber of valid It also repre- raging, which egisters. It is EVTMG1 or number of cy- as been com- ing the INT d	PF cycle cour error-free cyc sents the num affects the r incremented EVTMG2 sec cles defined I pleted and the evice pin to the ne TOF differ	cles that eith mber of TOF esults provid every time a quence. Bed by the TOF of the TOF_EVT be asserted (er of the EV DIFF cycle ded in the TC an error-free ause of this difference ma MG bit has b (if enabled),	TMG1 or s that have F_DIFF_ TOF_DIFF nternal isurements been set the TOF	
		BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0	
			DIIO	I		I	l	DIII		
		MSB		TUF	Cycle count &	B-bit binary in	liegei		LSB	

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ ONLY ADDRESS	NAME	DESCRIPTION
E5h	TOF_DIFF_ AVGInt	$\begin{array}{c} \mbox{16-bit fixed-point two's-complement integer portion of the average of the accumulated TOF_DIFF measurements. It is computed as: \label{eq:top_def} \underline{\sum_{n=1}^{\text{TOF}_Cycle_Count} \text{TOF}_DIFFn}_{n=1} \\ \hline \mbox{TOF}_Cycle_Count} \\ \mbox{This integer represents the number of } t_{4MHz} \mbox{ periods that contribute to the computation. The maximum size of the integer is 7FFFh or (2^{15} - 1) x t_{4MHz}. \\ \mbox{The minimum size of this integer is } t_{4MHz} \mbox{.} \end{array}$
E6h	TOF_DIFF_ AVGFrac	16-bit fractional portion of the two's-complement average of the accumulated TOF_DIFF measurements. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
E7h	T1Int	15-bit fixed-point integer value of the time taken to discharge the timing capacitor through the RTD connected to the T1 device pin. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .
E8h	T1Frac	16-bit fractional value of the time taken to charge the timing capacitor through the RTD connected to the T1 device pin. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
E9h	T2Int	15-bit fixed-point integer value of the time taken to charge the timing capacitor through the RTD connected to the T2 device pin. This integer portion is a binary representation of the number of periods that contribute to the time results. The maximum size of the integer is 7FFFh or $(2^{15} - 1) \times t_{4MHz}$.
EAh	T2Frac	16-bit fractional value of the time taken to charge the timing capacitor through the RTD connected to the T2 device pin. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
EBh	T3Int	15-bit fixed-point integer value of the time taken to charge the timing capacitor through the RTD connected to the T3 device pin. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .
ECh	T3Frac	16-bit fractional value of the time taken to charge the timing capacitor through the RTD connected to the T3 device pin. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
EDh	T4Int	15-bit fixed-point integer value of the time taken to charge the timing capacitor through the RTD connected to the T4 device pin. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

READ ONLY ADDRESS	NAME	DESCRIPTION							
EEh	T4Frac	16-bit fractional value of the time taken to charge the timing capacitor through the RTD connected to the T4 device pin. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .							
EFh	Temp_Cycle_ Count	The temp cycle count is an 8-bit binary integer that indicates the number of valid error-free cycles that either of the EVTMG1 or EVTMG3 commands has executed. It also represents the number of temperature cycles that have been totaled for the purpose of averaging, which affects the results provided in the Tx_AVGFrac and Tx_AVGInt registers. It is incremented every time an error-free temperature command is executed by either the EVTMG1 or EVTMG3 sequence. Because of this internal error checking, once the complete number of cycles defined by the temperature measurements bits in the Event Timing 2 register has been completed and the Temp_EVTMG bit has been set in the Interrupt Status register causing the INT device pin to be asserted (if enabled), the temperature cycle count may not be equal to the setting of the temperature measurements bits in the Event Timing 2 register.							
		BIT 15	BIT 14	BIT 13	BIT 12	BIT 11	BIT 10	BIT 9	BIT 8
		Х	Х	X	Х	х	X	Х	Х
		BIT 7 MSB	BIT 6	BIT 5 mp Cycle Col	BIT 4	BIT 3	BIT 2	BIT 1	LSB
F0h	T1_AVGInt	15-bit fixed-point integer value of the average of the T1 port measurements. It is computed as: $ \frac{\sum_{n=1}^{\text{Temp_Cycle_Count}} T1_n}{\text{Temp_Cycle_Count}} $ This integer portion is a binary representation of the number of t _{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t _{4MHz} .					tribute to		
F1h	T1_AVGFrac	16-bit fractional portion of the average of the T1 port measurements. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .							
F2h	T2_AVGInt	15-bit fixed-point integer value of the average of the T2 port measurements. It is computed as: $\begin{array}{r} \underbrace{\sum_{n=1}^{\text{Temp}_C \text{cycle}_Count}}{\text{Temp}_C \text{ycle}_Count} \\ \hline \text{This integer portion is a binary representation of the number of } t_{4MHz} \text{ periods that contribute to the time results. The maximum size of the integer is 7FFFh or (215 - 1) x t_{4MHz}. \end{array}$							

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 24. Conversion Results Registers Description (continued)

READ ONLY ADDRESS	NAME	DESCRIPTION
F3h	T2_AVGFrac	16-bit fractional portion of the average of the T2 port measurements. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
F4h	T3_AVGInt	15-bit fixed-point integer value of the average of the T3 port measurements. It is computed as:
F5h	T3_AVGFrac	16-bit fractional portion of the average of the T3 port measurements. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
F6h	T4_AVGInt	15-bit fixed-point integer value of the average of the T4 port measurements. It is computed as:
F7h	T4_AVGFrac	16-bit fractional portion of the average of the T4 port measurements. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or (2 ¹⁶ - 1)/2 ¹⁶ x t_{4MHz} .
F8h	Calibration Int	15-bit fixed-point integer value of the time taken to measure the period of the 32.768kHz crystal oscillator during execution of the calibrate command. This integer portion is a binary representation of the number of t_{4MHz} periods that contribute to the time results. The maximum size of the integer is 7FFFh or (2 ¹⁵ - 1) x t_{4MHz} .
F9h	Calibration Frac	16-bit fractional value of the time taken to measure the period of the 32.768kHz crystal oscillator during execution of the calibrate command. This fractional portion is a binary representation of one t_{4MHz} period quantized to a 16-bit resolution. The maximum size of the fraction is FFFFh or $(2^{16} - 1)/2^{16} \times t_{4MHz}$.
FAh		Reserved
FBh		Reserved
FCh		Reserved
FDh		Reserved

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Flash Opcode Commands

To access the flash memory, the internal low-dropout voltage regulator that powers the flash circuitry must be enabled. This can be done two ways: sending the LDO_Timed command prior to the desired flash access or sending the LDO_ON command to the MAX35103 prior to desired flash access. See the LDO_Timed and LDO_ON command descriptions for details. To manipulate the flash memory, there are three commands supported by the device: read flash, write flash, and block erase flash.

Read Flash Command

The read flash command is used to sequentially read a continuous stream of data from the internal 8KB of flash using a built-in autoincrement address counter. For 8KB, 13 address bits are needed to indicate the starting address in memory to begin the read stream. Since the memory array is organized in X16 fashion, the starting address must fall on any even number address. The read stream continues until the \overline{CE} signal is deasserted. Once the automatic internal address counter has been incremented to the last memory location in the array, it wraps around to the bottom of the memory array and the data for the first memory location of the array is read. Figure 18 illustrates the serial peripheral interface signaling associated with the read flash command.

Write Flash Command

The flash is written in the MAX35103 in a word-only manner. The architecture allows a single 16-bit word to be written to the array supporting the maximum access SPI clock speed of t_{SCK} . The location to be programmed must have previously been erased with the block erase flash command.

To perform a write flash command, the starting flash memory address must fall on an even flash memory address (i.e., the least significant bit of the address (A15–A0) must be 0). The 16-bit address word and at least one 16-bit word of data must be clocked into the device before the \overline{CE} pin is deasserted. If more than 16 bits of data are clocked into the device during a single \overline{CE} assertion, only the last bounded 16-bit data word is written. This is not a FIFO register. Any fraction of a 16-bit word is ignored, and the previous whole 16-bit word is written.

Once the 16 bits of data are clocked into the device, the host microprocessor deasserts the \overline{CE} device pin and then waits. The MAX35103 sets the flash bit in the Interrupt Status register and assert the \overline{INT} device pin (if enabled) to tell the host microprocessor that the next write flash command can be sent to the MAX35103. The host microprocessor can then read the Interrupt Status register after the INT device pin is asserted. Figure 19 illustrates the serial peripheral interface signaling associated with the write flash command.

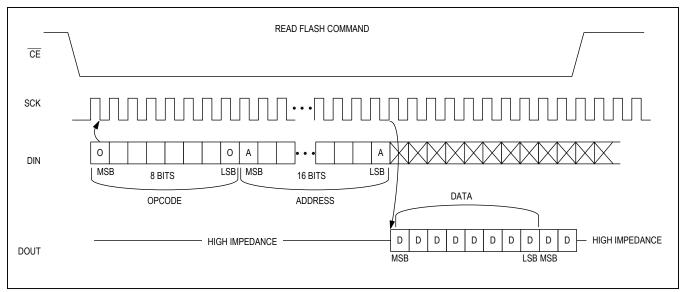


Figure 18. Read Flash Opcode Command Protocol

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Block Erase Flash Command

A block of 128 words (256 bytes) can be erased in a single operation. For the 8KB array, there are 32 such 128 word (256 Byte) blocks. The block to be erased is selected by the 16-bit address word in the block erase flash SPI protocol sequence as illustrated in Figure 20.

The erased block is the block that contains the specified address. The time from \overline{CE} deassert to \overline{CE} assert for the next block erase flash command needs to be approximately t_{ERASE}. Also, the device sets the flash bit in the Interrupt Status register and asserts the \overline{INT} device pin

(if enabled) to tell the host microprocessor that the next block erase flash command can be sent. The host microprocessor can read the Interrupt Status register after the INT device pin is asserted instead of waiting for t_{ERASE} .

Flash Memory Map

This memory is accessed by the read flash, write flash, and the block erase flash commands. All flash memory is erased when the MAX35103 leaves the factory. This means that each flash location has a value of FFFFh until written by a user to a different value.

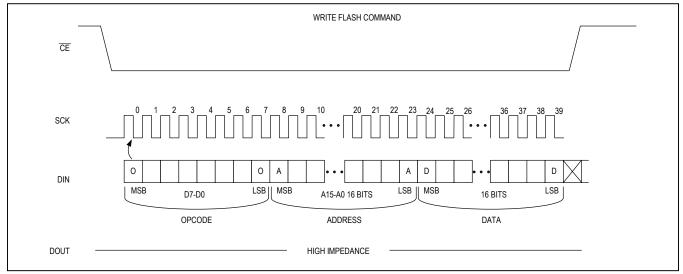


Figure 19. Write Flash Opcode Command Protocol

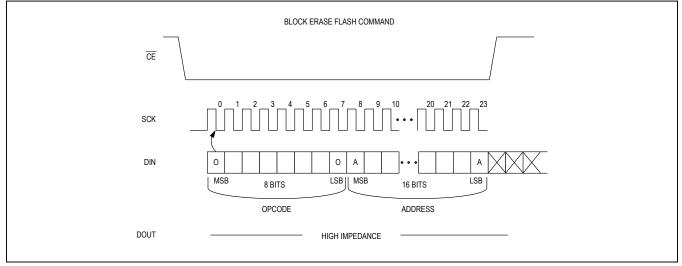


Figure 20. Block Erase Flash Opcode Command Protocol

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Table 25. Flash Memory Map

FLASH ADDRESS (evens only)	BLOCK (decimal)	DESCRIPTION
0000h to 00FFh	0	User flash
0100h to 01FFh	1	User flash
0200h to 02FFh	2	User flash
		User flash
1D00h to 1DFFh	29	User flash
1E00h to 1EFFh	30	User flash
1F00h to 1FFFh	31	User flash

Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX35103EHJ+	-40°C to +85°C	32 TQFP-EP*
MAX35103EHJ+T	-40°C to +85°C	32 TQFP-EP*

+Denotes a lead(Pb)-free/RoHS-compliant package.

T = Tape and reel.

*EP = Exposed pad.

Chip Information

PROCESS: CMOS

Package Information

For the latest package outline information and land patterns (footprints), go to <u>www.maximintegrated.com/packages</u>. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE	PACKAGE	OUTLINE	LAND
TYPE	CODE	NO.	PATTERN NO.
32 TQFP-EP	H32E+6	<u>21-0079</u>	<u>90-0326</u>

Reduced Power Time-to-Digital Converter with AFE, RTC, and Flash

Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED	
0	10/14	Initial release	—	
1	1/15	Updated Figure 12	21	

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim Integrated's website at www.maximintegrated.com.

Maxim Integrated cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim Integrated product. No circuit patent licenses are implied. Maxim Integrated reserves the right to change the circuitry and specifications without notice at any time. The parametric values (min and max limits) shown in the Electrical Characteristics table are guaranteed. Other parametric values quoted in this data sheet are provided for guidance.

Maxim Integrated and the Maxim Integrated logo are trademarks of Maxim Integrated Products, Inc. © 2015 Maxim Integrated Products, Inc. 67